To our customers,

Old Company Name in Catalogs and Other Documents

On April 1st, 2010, NEC Electronics Corporation merged with Renesas Technology Corporation, and Renesas Electronics Corporation took over all the business of both companies. Therefore, although the old company name remains in this document, it is a valid Renesas Electronics document. We appreciate your understanding.

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April 1st, 2010
Renesas Electronics Corporation

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MOS INTEGRATED CIRCUIT

μPD78056FY,78058FY

8-BIT SINGLE-CHIP MICROCONTROLLER

Phase-out/Discontinued

DESCRIPTION

The μPD78056FY,78058FY reduce the electromagnetic interference (EMI) noise in comparison with the conventional μPD78056Y,78058Y. The μPD78056FY,78058FY belong to the μPD78058FY Subseries products of the 78K/0 Series. These microcontrollers include a variety of peripheral hardware, such as an 8-bit resolution A/D converter, 8-bit resolution D/A converter, timer, serial interface (supports I^{2}C bus mode), real-time output ports, and interrupt functions.

The μPD78P058FY, a one-time PROM which can be operated in the same supply voltage range as for the mask ROM version, and various development tools are also available.

Detailed function descriptions are provided in the following user's manual. Be sure to read them before designing.

μPD78058F, 78058FY Subseries User's Manual: U12068E

78K/0 Series User's Manual-Instruction: U12326E

FEATURES

- EMI noise reduction version (The overall peak level is reduced by 5 to 10 dB.)
- Large on-chip ROM & RAM

Items / Products	Program Memory (ROM)	Data Memory			Packages
		Internal High-Speed RAM	Buffer RAM	Internal Expansion RAM	
μPD78056FY	48 Kbytes	1024 bytes	32 bytes	None	80-pin plastic QFP (14 × 14 mm, resin thickness 2.7 mm) 80-pin plastic QFP (14 × 14 mm, resin thickness 1.4 mm) 80-pin plastic TQFP (fine pitch) (12 × 12 mm)**Note**
μPD78058FY	60 Kbytes			1024 bytes	

Note This package is available only for the μPD78058FY.

- External memory expansion space: 64 Kbytes
- Minimum instruction execution time can be varied from high-speed (0.4 μs) to ultra-low-speed (122 μs)
- I/O ports: 69 (N-ch open-drain: 4)
- 8-bit resolution A/D converter: 8 channels
- 8-bit resolution D/A converter: 2 channels
- Serial interface: 3 channels (supports I^{2}C bus mode: 1 channel)
- Timer: 5 channels
- Supply voltage: V_{DD} = 2.7 to 6.0 V

APPLICATIONS

Cellular phones, pagers, printers, AV equipment, air conditioners, cameras, PPC, fuzzy home appliances, vending machines, etc.

The information in this document is subject to change without notice.

The mark ★ shows major revised points.

Phase-out/Discontinued

ORDERING INFORMATION

Part Number	Package

μPD78056FYGC-×××-3B9   80-pin plastic QFP (14 × 14 mm, resin thickness 2.7 mm)

★ μPD78056FYGC-×××-8BT   80-pin plastic QFP (14 × 14 mm, resin thickness 1.4 mm)

μPD78058FYGC-×××-3B9   80-pin plastic QFP (14 × 14 mm, resin thickness 2.7 mm)

★ μPD78058FYGC-×××-8BT   80-pin plastic QFP (14 × 14 mm, resin thickness 1.4 mm)

μPD78058FYGK-×××-BE9   80-pin plastic TQFP (fine pitch) (12 × 12 mm)

Caution   **The** μ**PD78056FYGC,** μ**PD78058FYGC come in two types of packages (see 12 Package Drawings).**
For the packages that can be supplied, consult your local NEC sales representative.

Remark   ××× denotes the ROM code number.

★ **78K/0 SERIES PRODUCT DEVELOPMENT**

These products are a further development in the 78K/0 Series. The designations appearing inside the boxes are subseries names.

Products in mass production

Products under development
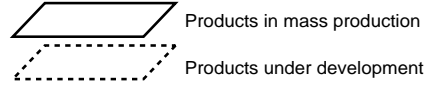
Y subseries products are compatible with I²C bus.

Control

Pin			Description
100-pin	μPD78075B	μPD78075BY	EMI noise reduction version of the μPD78078
100-pin	μPD78078	μPD78078Y	A timer was added to the μPD78054 and external interface function was enhanced
100-pin	μPD78070A	μPD78070AY	ROM-less versions of the μPD78078
100-pin		μPD780018AY	Serial I/O of the μPD78078Y was enhanced and only selected functions are provided
80-pin	μPD780058	μPD780058Y**Note**	Serial I/O of the μPD78054 was enhanced, EMI noise reduction version
80-pin	μPD78058F	μPD78058FY	EMI noise reduction version of the μPD78054
80-pin	μPD78054	μPD78054Y	UART and D/A converter were added to the μPD78014 and I/O was enhanced
64-pin	μPD780034	μPD780034Y	A/D converter of the μPD780024 was enhanced
64-pin	μPD780024	μPD780024Y	Serial I/O of the μPD78018F was enhanced, EMI noise reduction version
64-pin	μPD78014H		EMI noise reduction version of the μPD78018F
64-pin	μPD78018F	μPD78018FY	Low-voltage (1.8 V) operation versions of the μPD78014 with several ROM and RAM capacities are available
64-pin	μPD78014	μPD78014Y	An A/D converter and 16-bit timer were added to the μPD78002
64-pin	μPD780001		An A/D converter was added to the μPD78002
64-pin	μPD78002	μPD78002Y	Basic subseries for control
42/44pin	μPD78083		On-chip UART, capable of operating at a low voltage (1.8 V)

Inverter Control

64-pin	μPD780988	Inverter control, timer and SIO of the μPD780964 were enhanced and ROM and RAM were expanded
64-pin	μPD780964	A/D converter of the μPD780924 was enhanced
64-pin	μPD780924	On-chip inverter control circuit and UART, EMI noise reduction version

78K/0 series

FIP™ drive

100-pin	μPD780208	The I/O and FIP C/D of the μPD78044F were enhanced, Display output total: 53
100-pin	μPD780228	The I/O and FIP C/D of the μPD78044H were enhanced, Display output total: 48
80-pin	μPD78044H	N-ch open drain I/O was added to the μPD78044H, Display output total: 34
80-pin	μPD78044F	Basic subseries for driving FIP, Display output total: 34

LCD drive

100-pin	μPD780308	μPD780308Y	SIO of the μPD78064 was enhanced and ROM and RAM were expanded
100-pin	μPD78064B		EMI noise reduction version of the μPD78064
100-pin	μPD78064	μPD78064Y	Subseries for driving LCDs, On-chip UART

IEBus™ supported

80-pin	μPD78098B	EMI noise reduction version of the μPD78098
80-pin	μPD78098	The IEBus contorller was added to the μPD78098

Meter control

80-pin	μPD780973	On-chip the controller /driver for automobile meter drive

LV

64-pin	μPD78P0914	On-chip PWM output, LV digital code decoder, Hsync counter

Note Under planning

The major functional differences among the Y subseries are shown below.

Subseries	Function	ROM Capacity	Serial Interface		I/O	V_{DD} MIN. Value
Control	μPD78075BY	32 K to 40 K	3-wire/2-wire/I²C	: 1 ch	88	1.8 V
	μPD78078Y	48 K to 60 K	3-wire with automatic send/receive function : 1 ch			
	μPD78070AY	—	3-wire/UART	: 1 ch	61	2.7 V
	μPD780018AY	48 K to 60 K	3-wire with automatic send/receive function : 1 ch		88	
			Time division 3-wire : 1 ch			
			I²C bus (supports multimaster) : 1 ch			
	μPD780058Y	24 K to 60 K	3-wire/2-wire/I²C	: 1 ch	68	1.8 V
			3-wire with automatic send/receive function : 1 ch			
			3-wire/time division UART : 1 ch			
	μPD78058FY	48 K to 60 K	3-wire/2-wire/I²C	: 1 ch	69	2.7 V
	μPD78054Y	16 K to 60 K	3-wire with automatic send/receive function : 1 ch			2.0 V
			3-wire/UART : 1 ch			
	μPD780034Y	8 K to 32 K	UART	: 1 ch	51	1.8 V
	μPD780024Y		3-wire : 1 ch			
			I²C bus (supports multimaster) : 1 ch			
	μPD78018FY	8 K to 60 K	3-wire/2-wire/I²C	: 1 ch	53	
			3-wire with automatic send/receive function : 1 ch			
	μPD78014Y	8 K to 32 K	3-wire/2-wire/SBI/I²C	: 1 ch		2.7 V
			3-wire with automatic send/receive function : 1 ch			
	μPD78002Y	8 K to 16 K	3-wire/2-wire/SBI/I²C	: 1 ch		
LCD driving	μPD780308Y	48 K to 60 K	3-wire/2-wire/I²C	: 1 ch	57	2.0 V
			3-wire/time-division UART : 1 ch			
			3-wire : 1 ch			
	μPD78064Y	16 K to 32 K	3-wire/2-wire/I²C	: 1 ch		
			3-wire/UART : 1 ch			

Remark The functions, except for the serial interface, are the same as those of subseries without Y.

OVERVIEW OF FUNCTION

Item	Product Name	μPD78056FY	μPD78058FY
Internal memory	ROM	48 Kbytes	60 Kbytes
	High-speed RAM	1024 bytes	
	Buffer RAM	32 bytes	
	Expanded RAM	None	1024 Kbytes
Memory space		64 Kbytes	
General registers		8 bits $\times$ 32 registers (8 bits $\times$ 8 registers $\times$ 4 banks)	
Minimum instruction execution		On-chip instruction execution time cycle modification function	
time	When main system clock selected	0.4 μs/0.8 μs/1.6 μs/3.2 μs/6.4 μs/12.8 μs (at 5.0-MHz operation)	
	When subsystem clock selected	122 μs (at 32.768-kHz operation)	
Instruction set		• 16-bit operation • Multiplication/division (8 bits $\times$ 8 bits, 16 bits $\div$ 8 bits) • Bit manipulation (set, reset, test, Boolean operation) • BCD correction, etc.	
I/O ports		Total : 69 • CMOS input : 2 • CMOS I/O : 63 • N-ch open-drain I/O : 4	
A/D converter		• 8-bit resolution $\times$ 8 channels	
D/A converter		• 8-bit resolution $\times$ 2 channels	
Serial interface		• 3-wire serial I/O/2-wire serial I/O/I²C bus mode selectable: 1 channel • 3-wire serial I/O mode (on-chip max. 32 bytes automatic data transmit/receive function): 1 channel • 3-wire serial I/O/UART mode selectable: 1 channel	
Timer		• 16-bit timer/event counter : 1 channel • 8-bit timer/event counter : 2 channels • Watch timer : 1 channel • Watchdog timer : 1 channel	
Timer output		3 (14-bit PWM output $\times$ 1)	
Clock output		19.5 kHz, 39.1 kHz, 78.1 kHz, 156 kHz, 313 kHz, 625 kHz, 1.25 MHz, 2.5 MHz, 5.0 MHz (at main system clock 5.0-MHz operation) 32.768 kHz (at subsystem clock 32.768-kHz operation)	
Buzzer output		1.2 kHz, 2.4 kHz, 4.9 kHz, 9.8 kHz (at main system clock 5.0-MHz operation)	
Vectored-interrupt source	Maskable	Internal : 13, external : 7	
	Non-maskable	Internal : 1	
	Software	1	
Test input		Internal : 1, external : 1	
Supply voltage		V_{DD} = 2.7 to 6.0 V	
Operating ambient temperature		T_A = $-$ 40 to + 85°C	
Package		• 80-pin plastic QFP (14 $\times$ 14 mm, resin thickness 2.7 mm) • 80-pin plastic QFP (14 $\times$ 14 mm, resin thickness 1.4 mm) • 80-pin plastic TQFP (fine pitch) (12 $\times$ 12 mm) **Note**	

Note μPD78058FY only

CONTENTS

Phase-out/Discontinued

1. PIN CONFIGURATION (TOP VIEW)

- **80-pin plastic QFP (14 × 14, resin thickness 2.7 mm)**
  µPD78056FYGC-×××-3B9
  µPD78058FYGC-×××-3B9

- **80-pin plastic TQFP (fine pich) (12 × 12 mm)**
  µPD78058FYGK-×××-BE9

- **80-pin plastic QFP (14 × 14, resin thickness 1.4 mm)**
  µPD78056FYGC-×××-8BT
  µPD78058FYGC-×××-8BT

Top pins (80–61):
P14/ANI4 (80), P13/ANI3 (79), P12/ANI2 (78), P11/ANI1 (77), P10/ANI0 (76), AV$_{REF0}$ (75), AV$_{DD}$ (74), XT1/P07 (73), XT2 (72), IC (71), X1 (70), X2 (69), V$_{DD}$ (68), P06/INTP6 (67), P05/INTP5 (66), P04/INTP4 (65), P03/INTP3 (64), P02/INTP2 (63), P01/INTP1/TI01 (62), P00/INTP0/TI00 (61)

Left pins (1–20):
P15/ANI5 (1), P16/ANI6 (2), P17/ANI7 (3), AV$_{SS}$ (4), P130/ANO0 (5), P131/ANO1 (6), AV$_{REF1}$ (7), P70/SI2/RxD (8), P71/SO2/TxD (9), P72/SCK2/ASCK (10), P20/SI1 (11), P21/SO1 (12), P22/SCK1 (13), P23/STB (14), P24/BUSY (15), P25/SI0/SB0/SDA0 (16), P26/SO0/SB1/SDA1 (17), P27/SCK0/SCL (18), P40/AD0 (19), P41/AD1 (20)

Right pins (60–41):
RESET (60), P127/RTP7 (59), P126/RTP6 (58), P125/RTP5 (57), P124/RTP4 (56), P123/RTP3 (55), P122/RTP2 (54), P121/RTP1 (53), P120/RTP0 (52), P37 (51), P36/BUZ (50), P35/PCL (49), P34/TI2 (48), P33/TI1 (47), P32/TO2 (46), P31/TO1 (45), P30/TO0 (44), P67/ASTB (43), P66/WAIT (42), P65/WR (41)

Bottom pins (21–40):
P42/AD2 (21), P43/AD3 (22), P44/AD4 (23), P45/AD5 (24), P46/AD6 (25), P47/AD7 (26), P50/A8 (27), P51/A9 (28), P52/A10 (29), P53/A11 (30), P54/A12 (31), P55/A13 (32), V$_{SS}$ (33), P56/A14 (34), P57/A15 (35), P60 (36), P61 (37), P62 (38), P63 (39), P64/RD (40)

Cautions

1. Connect directly the Internally Connected (IC) pin to V$_{SS}$.
2. The AV$_{DD}$ pin functions as both an A/D converter power supply and a port power supply. When the µPD78056FY and 78058FY are used in applications where the noise generated inside the microcontroller needs to be reduced, connect the AV$_{DD}$ pin to another power supply which has the same potential as V$_{DD}$.
3. The AV$_{SS}$ pin functions as both an A/D and D/A converter ground and as a port ground. When the µPD78056FY and 78058FY are used in applications where the noise generated inside the microcontroller needs to be reduced, connect the AV$_{SS}$ pin to a ground line other than V$_{SS}$.

A8 to A15	:	Address Bus
AD0 to AD7	:	Address/Data Bus
ANI0 to ANI7	:	Analog Input
ANO0, ANO1	:	Analog Output
ASCK	:	Asynchronous Serial Clock
ASTB	:	Address Strobe
AV_{DD}	:	Analog Power Supply
AV_{REF0}, AV_{REF1}	:	Analog Reference Voltage
AV_{SS}	:	Analog Ground
BUSY	:	Busy
BUZ	:	Buzzer Clock
IC	:	Internally Connected
INTP0 to INTP6	:	Interrupt from Peripherals
P00 to P07	:	Port0
P10 to P17	:	Port1
P20 to P27	:	Port2
P30 to P37	:	Port3
P40 to P47	:	Port4
P50 to P57	:	Port5
P60 to P67	:	Port6
P70 to P72	:	Port7
P120 to P127	:	Port12
P130, P131	:	Port13

PCL	:	Programmable Clock
$\overline{RD}$	:	Read Strobe
$\overline{RESET}$	:	Reset
RTP0 to RTP7	:	Real-Time Output Port
RxD	:	Receive Data
SB0, SB1	:	Serial Bus
$\overline{SCK0}$ to $\overline{SCK2}$	:	Serial Clock
SCL	:	Serial Clock
SDA0, SDA1	:	Serial Data
SI0 to SI2	:	Serial Input
SO0 to SO2	:	Serial Output
STB	:	Strobe
TI00, TI01	:	Timer Input
TI1, TI2,	:	Timer Input
TO0 to TO2	:	Timer Output
TxD	:	Transmit Data
V_{DD}	:	Power Supply
V_{SS}	:	Ground
$\overline{WAIT}$	:	Wait
$\overline{WR}$	:	Write Strobe
X1, X2	:	Crystal (Main System Clock)
XT1, XT2	:	Crystal (Subsystem Clock)

2. BLOCK DIAGRAM
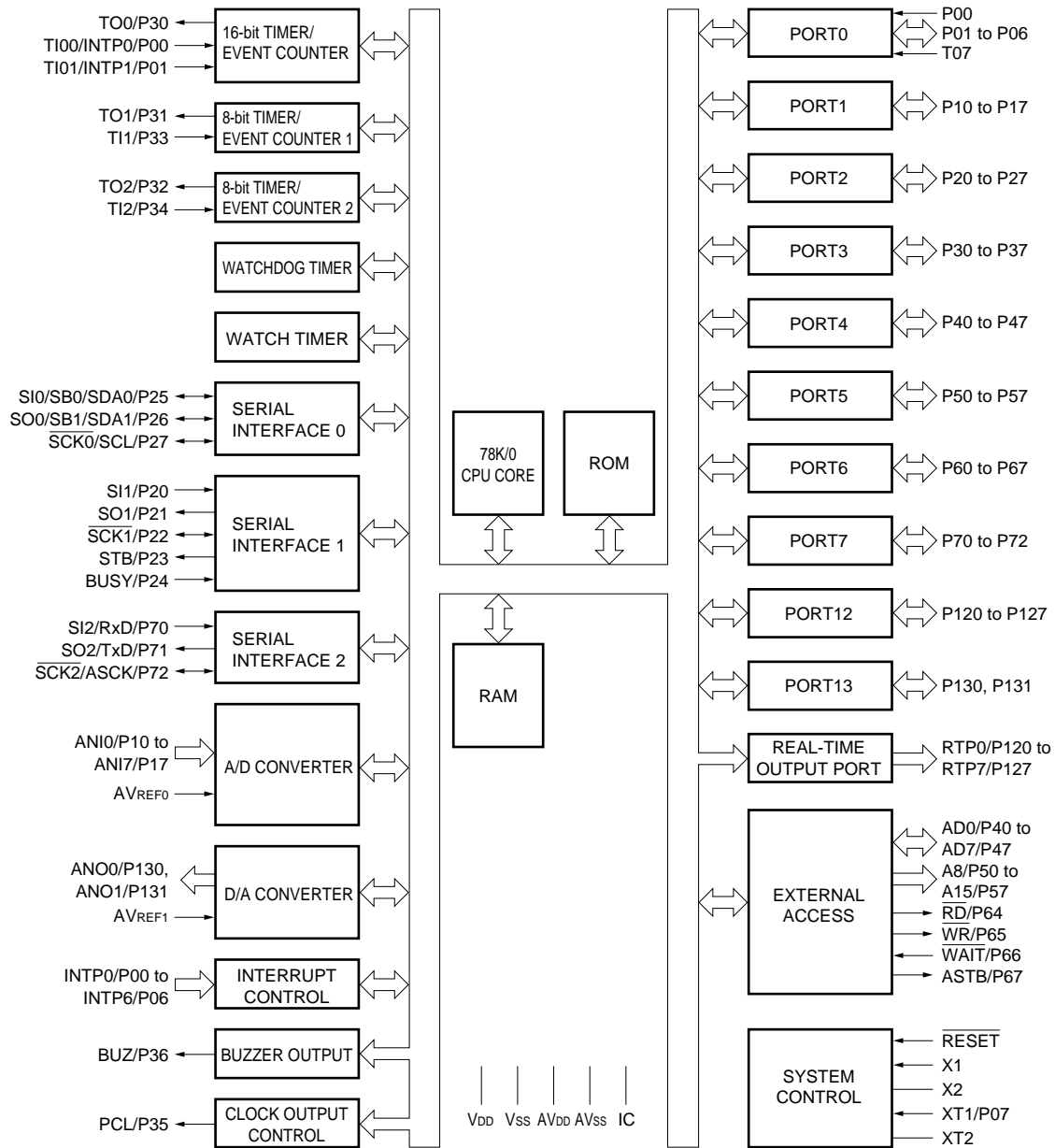
Remark The internal ROM and RAM capacity depends on the product.

3. PIN FUNCTIONS

3.1 Port Pins (1/2)

Pin Name	I/O	Function		After Reset	Alternate Function
P00	Input	Port 0 8-bit I/O port	Input only	Input	INTP0/TI00
P01	Input/ output		Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.	Input	INTP1/TI01
P02					INTP2
P03					INTP3
P04					INTP4
P05					INTP5
P06					INTP6
P07 **Note 1**	Input		Input only	Input	XT1
P10 to P17	Input/ output	Port 1 8-bit input/output port. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.**Note 2**		Input	ANI0 to ANI7
P20	Input/ output	Port 2 8-bit input/output port. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.		Input	SI1
P21					SO1
P22					$\overline{\text{SCK1}}$
P23					STB
P24					BUSY
P25					SI0/SB0/SDA0
P26					SO0/SB1/SDA1
P27					$\overline{\text{SCK0}}$/SCL
P30	Input/ output	Port 3 8-bit input/output port. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.		Input	TO0
P31					TO1
P32					TO2
P33					TI1
P34					TI2
P35					PCL
P36					BUZ
P37					—
P40 to P47	Input/ output	Port 4 8-bit input/output port. Input/output can be specified in 8-bit unit. When used as an input port, on-chip pull-up resistor can be used by software. Test input flag (KRIF) is set to 1 by falling edge detection.		Input	AD0 to AD7

Notes 1. When using the P07/XT1 pins as an input port, set 1 in bit 6 (FRC) of the processor clock control register. On-chip feedback resistor of the subsystem clock oscillator should not be used.

    2. When using the P10/ANI0 to P17/ANI7 pins as the A/D converter analog input pins, use of the on-chip pull-up resistor is cancelled automatically.

3.1 Port Pins (2/2)

Pin Name	I/O	Function		After Reset	Alternate Function
P50 to P57	Input/ output	Port 5 8-bit input/output port. LED can be driven directly. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.		Input	A8 to A15
P60	Input/ output	Port 6 8-bit input/outport port. Input/output can be specified bit-wise.	N-ch open-drain input/output port. On-chip pull-up resistor can be specified by mask option. LED can be driven directly.	Input	—
P61					
P62					
P63					
P64			When used as an input port, on-chip pull-up resistor can be used by software.	Input	$\overline{RD}$
P65					$\overline{WR}$
P66					$\overline{WAIT}$
P67					ASTB
P70	Input/ output	Port 7 3-bit input/output port. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.		Input	SI2/RxD
P71					SO2/TxD
P72					$\overline{SCK2}$/ASCK
P120 to P127	Input/ output	Port 12 8-bit input/output port. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.		Input	RTP0 to RTP7
P130, P131	Input/ output	Port 13 2-bit input/output port. Input/output can be specified bit-wise. When used as an input port, on-chip pull-up resistor can be used by software.		Input	ANO0, ANO1

Caution **For pins which also function as port pins, do not perform the following operations during A/D conversion. If these operations are performed, the total error ratings cannot be kept (except for LCD segment output alternate-function pin).**
   (1) Rewrite the output latch which the pin is used as a port pin.
   (2) Change the output level of the pin used as an output pin, even if it is not used as a port pin.

3.2 Non-port Pins (1/2)

Pin Name	I/O	Function	After Reset	Alternate Function
INTP0	Input	External interrupt request input by which the effective edge (rising edge, falling edge, or both rising edge and falling edge) can be specified.	Input	P00/TI00
INTP1				P01/TI01
INTP2				P02
INTP3				P03
INTP4				P04
INTP5				P05
INTP6				P06
SI0	Input	Serial interface serial data input.	Input	P25/SB0/SDA0
SI1				P20
SI2				P70/RxD
SO0	Output	Serial interface serial data output.	Input	P26/SB1/SDA1
SO1				P21
SO2				P71/TxD
SB0	Input /output	Serial interface serial data input/output.	Input	P25/SI0/SDA0
SB1				P26/SO0/SDA1
SDA0				P25/SI0/SB0
SDA1				P26/SO0/SBI
$\overline{\text{SCK0}}$	Input /output	Serial interface serial clock input/ output	Input	P27/SCL
$\overline{\text{SCK1}}$				P22
$\overline{\text{SCK2}}$				P72/ASCK
SCL				P27/$\overline{\text{SCK0}}$
STB	Output	Serial interface automatic transmit/receive strobe output.	Input	P23
BUSY	Input	Serial interface automatic transmit/receive busy input.	Input	P24
RxD	Input	Asynchronous serial interface serial data input.	Input	P70/SI2
TxD	Output	Asynchronous serial interface serial data output.	Input	P71/SO2
ASCK	Input	Asynchronous serial interface serial clock input.	Input	P72/$\overline{\text{SCK2}}$
TI00	Input	External count clock input to the 16-bit timer (TM0)	Input	P00/INTP0
TI01		Capture trigger signal input to the capture register (CR00)		P01/INTP1
TI1		External count clock input to the 8-bit timer (TM1)		P33
TI2		External count clock input to the 8-bit timer (TM2)		P34
TO0	Output	16-bit timer (TM0) output (alternate function as 14-bit PWM output)	Input	P30
TO1		8-bit timer (TM1) output		P31
TO2		8-bit timer (TM2)		P32
PCL	Output	Clock output (for main system clock, subsystem clock trimming).	Input	P35
BUZ	Output	Buzzer output.	Input	P36
RTP0 to RTP7	Output	Real-time output port by which data is output in synchronization with a trigger.	Input	P120 to P127
AD0 to AD7	Input /output	Low-order address/data bus at external memory expansion.	Input	P40 to P47

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3.2 Non-port Pins (2/2)

Pin Name	I/O	Function	After Reset	Alternate Function
A8 to A15	Output	High-order address bus at external memory expansion.	Input	P50 to P57
$\overline{RD}$	Output	External memory read operation strobe signal output.	Input	P64
$\overline{WR}$		External memory write operation strobe signal output.		P65
$\overline{WAIT}$	Input	Wait insertion at external memory access.	Input	P66
ASTB	Output	Strobe output which latches the address information output at port 4 to access external memory.	Input	P67
ANI0 to ANI7	Input	A/D converter analog input.	Input	P10 to P17
ANO0, ANO1	Output	D/A converter analog output.	Input	P130, P131
AV_{REF0}	Input	A/D converter reference voltage input.	—	—
AV_{REF1}	Input	D/A converter reference voltage input.	—	—
AV_{DD}	—	A/D converter analog power supply (shared with the port power supply)	—	—
AV_{SS}	—	A/D and D/A converter ground potential (shared with the port ground potential)	—	—
$\overline{RESET}$	Input	System reset input.	—	—
X1	Input	Main system clock oscillation crystal connection.	—	—
X2	—		—	—
XT1	Input	Subsystem clock oscillation crystal connection.	Input	P07
XT2	—		—	—
V_{DD}	—	Positive power supply (except for port).	—	—
V_{SS}	—	Ground potential (except for port).	—	—
IC	—	Internally connected. Connect directly to V_{SS}.	—	—

Cautions 1. The AV_{DD} pin functions as both an A/D converter power supply and a port power supply. When the μPD78056FY and 78058FY are used in applications where the noise generated inside the microcontroller needs to be reduced, connect the AV_{DD} pin to another power supply which has the same potential as V_{DD}.

2. The AV_{SS} pin functions as both an A/D converter and D/A converter ground and as a port ground.   When the μPD78056FY and 78058FY are used in applications where the noise generated inside the microcontroller needs to be reduced, connect the AV_{SS} pin to a ground line other than V_{SS}.

3.3 Pin I/O Circuits and Recommended Connection of Unused Pins

The input/output circuit type of each pin and recommended connection of unused pins are shown in Table 3-1.

For the input/output circuit configuration of each type, see Figure 3-1.

Table 3-1. Input/Output Circuit Type of Each Pin (1/2)

Pin Name	Input/output Circuit Type	I/O	Recommended Connection when not Used
P00/INTP0/TI00	2	Input	Connected to Vss.
P01/INTP1/TI01	8-D	Input/output	Independently connect to Vss through resistor.
P02/INTP2			
P03/INTP3			
P04/INTP4			
P05/INTP5			
P06/INTP6			
P07/XT1	16	Input	Connect to VDD.
P10/ANI0 to P17/ANI7	11-C	Input/output	Independently connect to VDD or Vss through resistor.
P20/SI1	8-D		
P21/SO1	5-J		
P22/SCK1	8-D		
P23/STB	5-J		
P24/BUSY	8-D		
P25/SI0/SB0/SDA0	10-C		
P26/SO0/SB1/SDA1			
P27/SCK0/SCL			
P30/TO0	5-J		
P31/TO1			
P32/TO2			
P33/TI1	8-D		
P34/TI2			
P35/PCL	5-J		
P36/BUZ			
P37			
P40/AD0 to P47/AD7	5-O		Independently connect to VDD through resistor.
P50/A8 to P57/A15	5-J		Independently connect to VDD or Vss through resistor.
P60 to P63	13-I		Independently connect to VDD through resistor.
P64/RD	5-J		Independently connect to VDD or Vss through resistor.
P65/WR			
P66/WAIT			
P67/ASTB			

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Phase-out/Discontinued

Table 3-1. Input/Output Circuit Type of Each Pin (2/2)

Pin Name	Input/output Circuit Type	I/O	Recommended Connection when not Used
P70/SI2/RxD	8-D	Input/ output	Independently connect to V_{DD} or V_{SS} through resistor.
P71/SO2/TxD	5-J		
P72/$\overline{SCK2}$/ASCK	8-D		
P120/RTP0 to P127/RTP7	5-J		
P130/ANO0 , P131/ANO1	12-B	Input/ output	Independently connect to V_{SS} through resistor.
$\overline{RESET}$	2	Input	—
XT2	16	—	Leave open.
AV_{REF0}	—		Connect to V_{SS}.
AV_{REF1}			Connect to V_{DD}.
AV_{DD}			Connect to another power supply which has the same potential as V_{DD}.
AV_{SS}			Connect to another ground line which has the same potential as V_{SS}.
IC			Connect directly to V_{SS}.

Phase-out/Discontinued

Figure 3-1. Pin Input/Output Circuits (1/2)
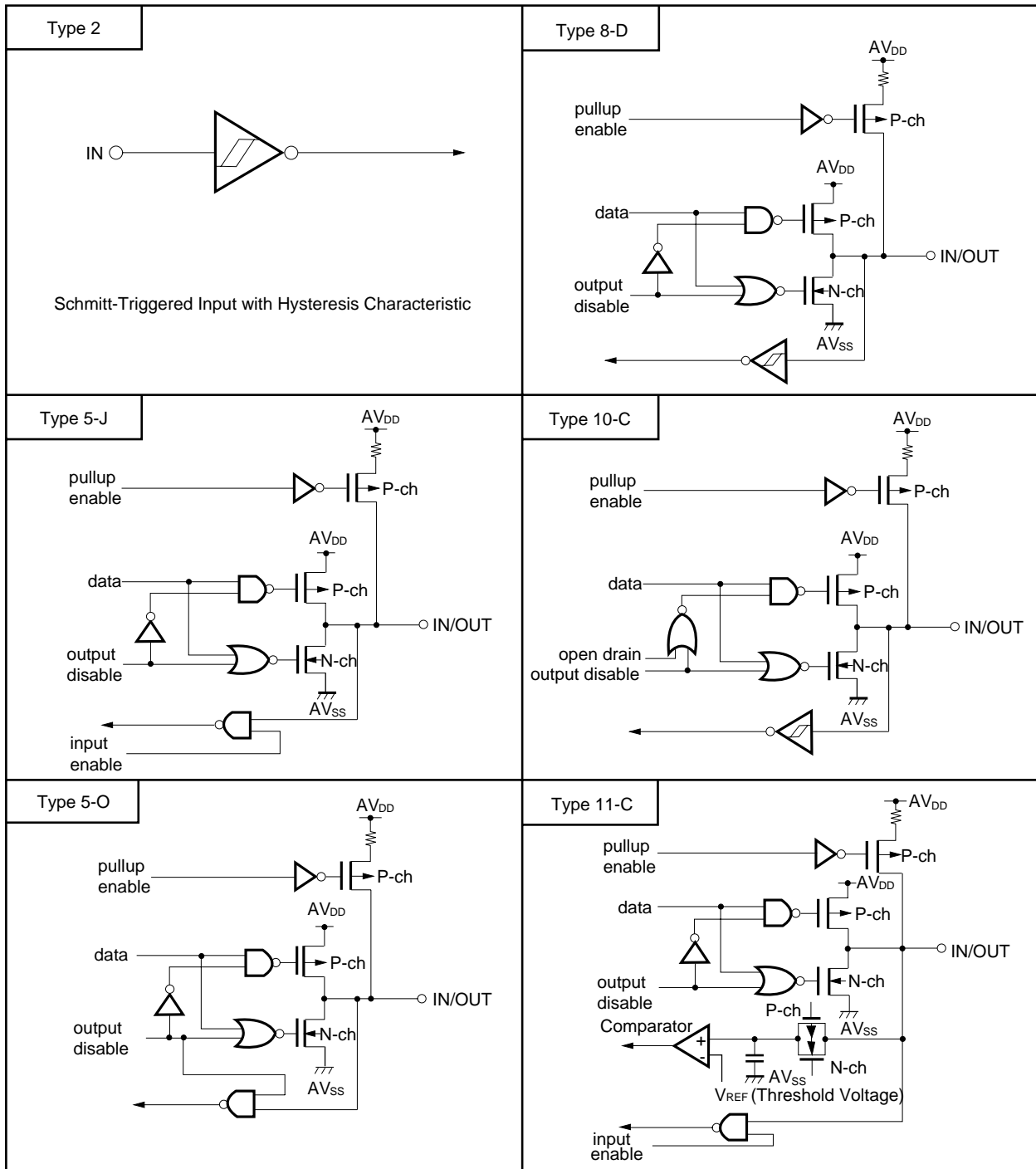
Figure 3-1. Pin Input/Output Circuits (2/2)
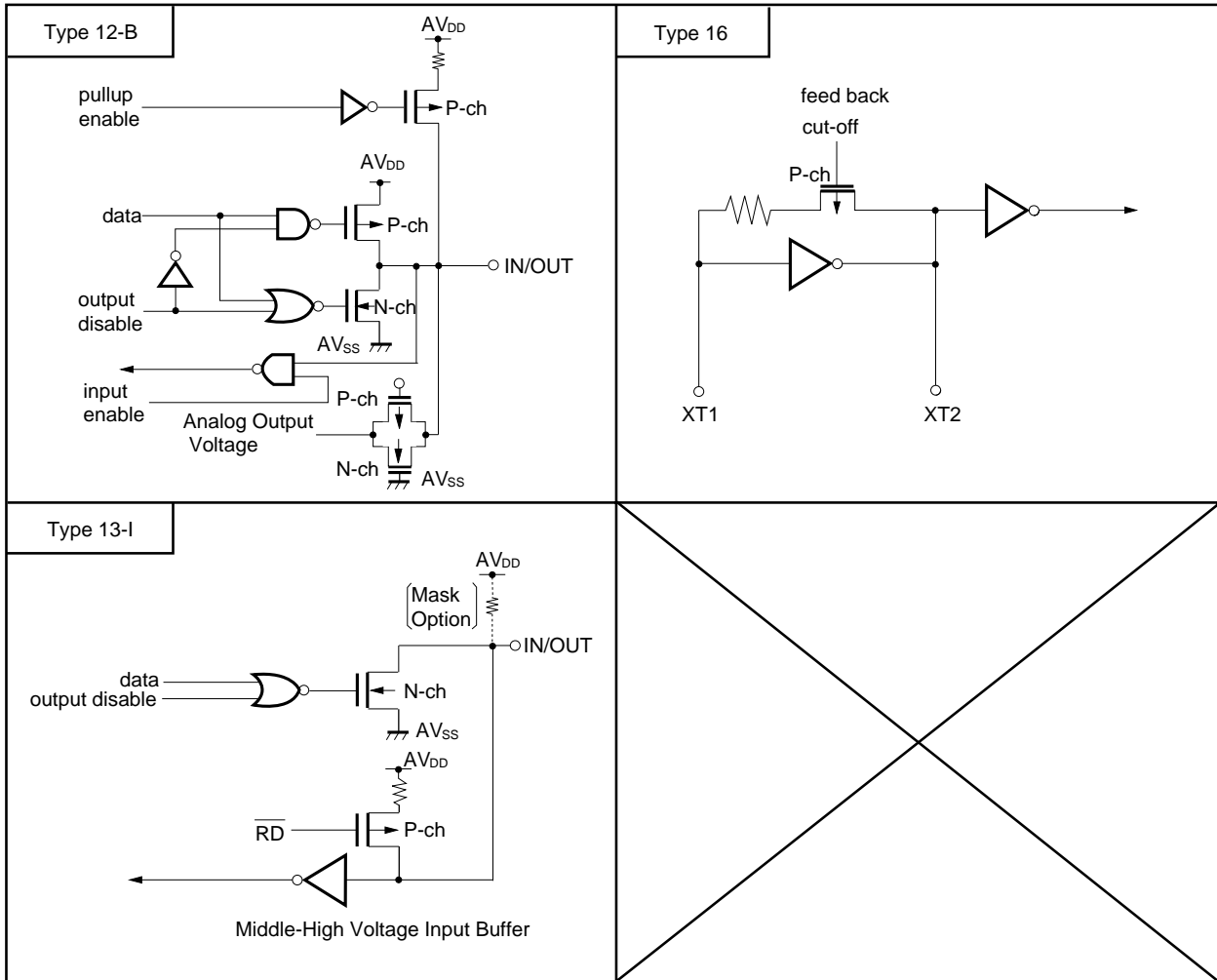
4. MEMORY SPACE

Figure 4-1 shows the memory map of the μPD78056FY,78058FY.

Figure 4-1. Memory Map
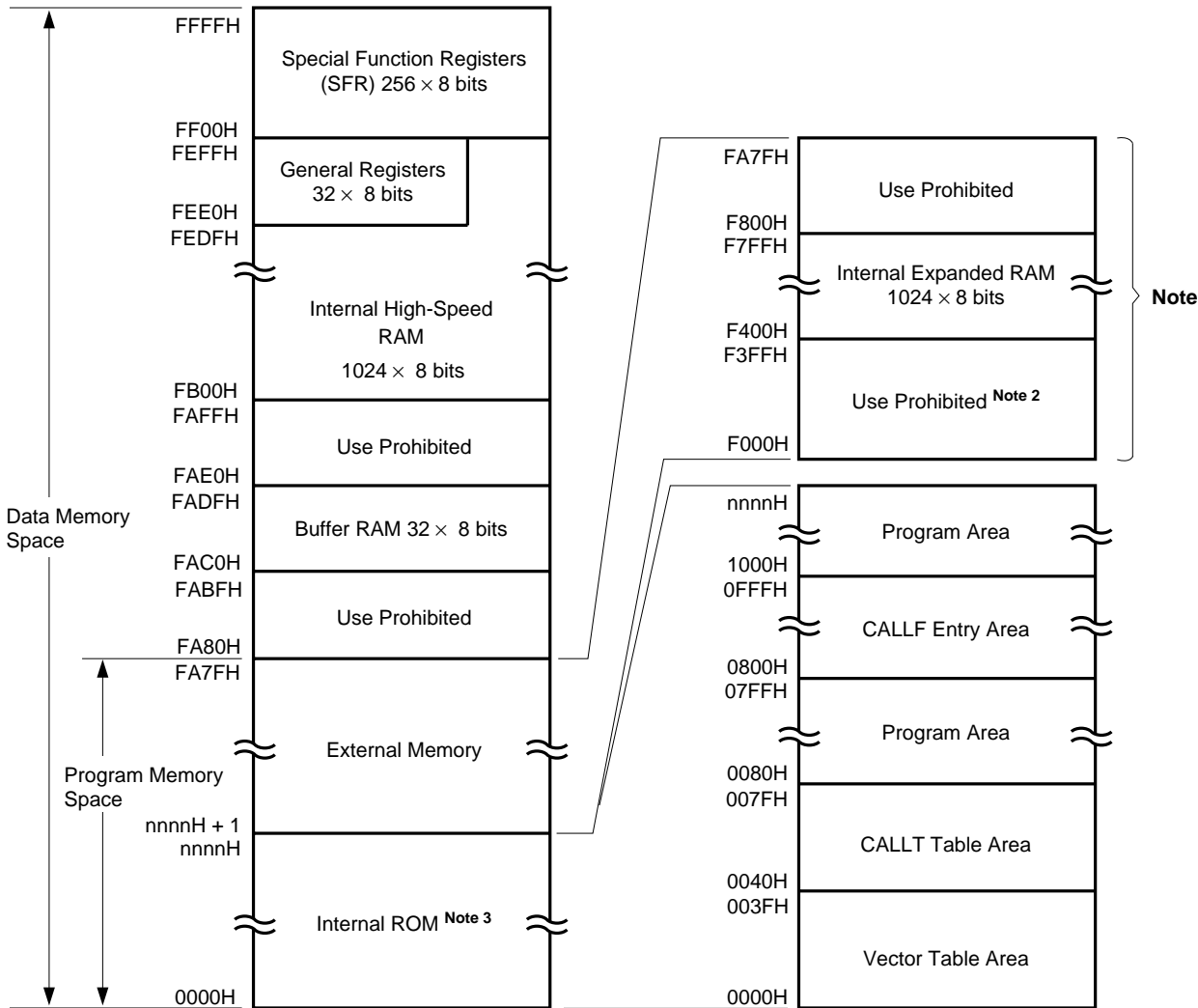
Notes 1. μPD78058FY only

    2. When the external device expansion function is used with the μPD78058FY, set the internal ROM capacity to 56 Kbytes or less using the memory size switching register (IMS).

    3. The internal ROM capacity and internal high-speed RAM capacity depend on the products (see the table below).

Target Product	Internal ROM Last Address nnnnH
μPD78056FY	BFFFH
μPD78058FY	EFFFH

Phase-out/Discontinued

5. PERIPHERAL HARDWARE FUNCTION FEATURES

5.1 Ports

The following 3 types of I/O ports are available.

- CMOS input (P00, P07)   :   2
- CMOS input/output (P01 to P06, port 1 to port 5, P64 to P67, port 7, port 12, port 13)   : 63
- N-channel open-drain input/output (P60 to P63)   :   4

Total   : 69

Table 5-1. Port Functions

Name	Pin Name	Function
Port 0	P00, P07	Dedicated input port pins
	P01 to P06	Input/output port pins. Input/output specifiable bit-wise. When used as input/output port pins, on-chip pull-up resistor can be used by software.
Port 1	P10 to P17	Input/output port pins. Input/output specifiable bit-wise. When used as input port pins, on-chip pull-up resistor can be used by software.
Port 2	P20 to P27	Input/output port pins. Input/output specifiable bit-wise. When used as input port pins, on-chip pull-up resistor can be used by software.
Port 3	P30 to P37	Input/output port pins. Input/output specifiable bit-wise. When used as input port pins, on-chip pull-up resistor can be used by software.
Port 4	P40 to P47	Input/output port pins. Input/output specifiable in 8-bit units. When used as input port pins, on-chip pull-up resistor can be used by software. Test input flag (KRIF) is set to 1 by falling edge detection.
Port 5	P50 to P57	Input/output port pins. Input/output specifiable bit-wise. When used as input port pins, on-chip pull-up resistor can be used by software. LED direct drive capability.
Port 6	P60 to P63	N-channel open-drain input/output port pins. Input/output specifiable bit-wise. On-chip pull-up resistor can be used by mask option. LED direct drive capability.
	P64 to P67	Input/output port pins. Input/output specifiable bit-wise. When used as input/output port pins, on-chip pull-up resistor can be used by software.
Port 7	P70 to P72	Input/output port pins. Input/output specifiable bit-wise. When used as input/output port pins, on-chip pull-up resistor can be used by software.
Port 12	P120 to P127	Input/output port pins. Input/output specifiable bit-wise. When used as input/output port pins, on-chip pull-up resistor can be used by software.
Port 13	P130, P131	Input/output port pins. Input/output specifiable bit-wise. When used as input/output port pins, on-chip pull-up resistor can be used by software.

5.2 Clock Generator

Two types of generators, a main system clock generator and a subsystem clock generator, are avaibable.

The minimum instruction execution time can also be changed.

- 0.4 μs/0.8 μs/1.6 μs/3.2 μs/6.4 μs/12.8 μs (main system clock: at 5.0-MHz operation)
- 122 μs (subsystem clock: at 32.768-kHz operation)

Figure 5-1. Clock Generator Block Diagram
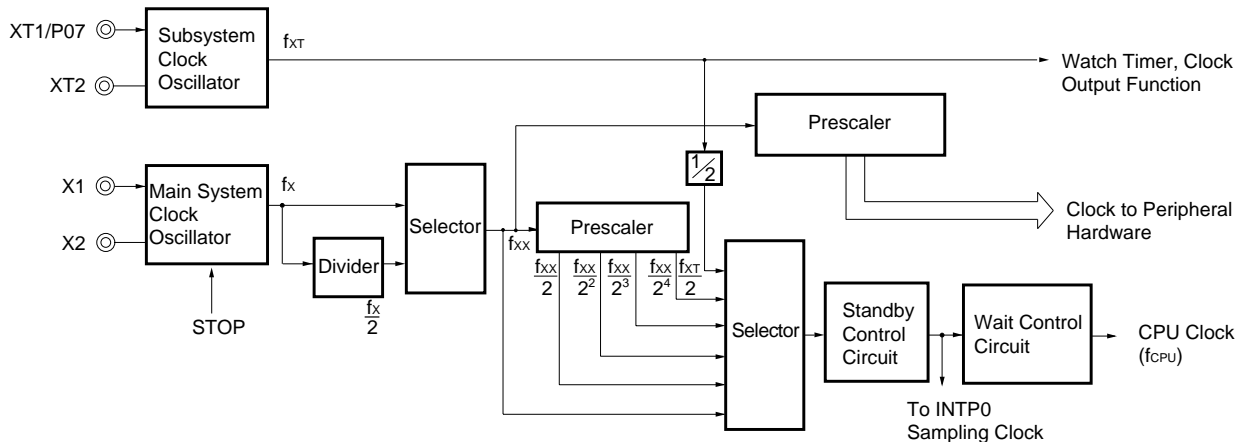
5.3 Timer/Event Counter

5 timer/event counter channels are incorporated.

- 16-bit timer/event counter : 1 channel
- 8-bit timer/event counter : 2 channels
- Watch timer : 1 channel
- Watchdog timer : 1 channel

Table 5-2. Operation of Timer/Event Counter

	16-Bit Timer/Event Counter	8-Bit Timer/Event Counter	Watch Timer	Watchdog Timer
Operation mode				
Interval timer	1 channel	2 channels	1 channel	1 channel
External event counter	1 channel	2 channels	——	——
Function				
Timer output	1 output	2 outputs	——	——
PWM output	1 output	——	——	——
Pulse width measurement	2 input	——	——	——
Square wave output	1 output	2 outputs	——	——
One-shot pulse output	1 output	——	——	——
Interrupt request	2	2	1	1
Test input	——	——	1 input	——

Phase-out/Discontinued

Figure 5-2. 16-Bit Timer/Event Counter Block Diagram

Internal Bus

INTP1

TI01/P01/INTP1

Selector

16-Bit Capture/
Compare Register
(CR00)

INTTM00

Watch Timer
Output

$2f_{xx}$

f_{xx}

$f_{xx}/2$

$f_{xx}/2^2$

Selector

Match

PWM pulse
Output
Control
Circuit

Output Control
Circuit

TO0/P30

16-Bit Timer Register
(TM0)

Clear

Selector

TI00/P00/INTP0

Edge
Detction
Circuit

Match

INTTM01

INTP0

16-Bit Capture/
Compare Register
(CR01)

Internal Bus
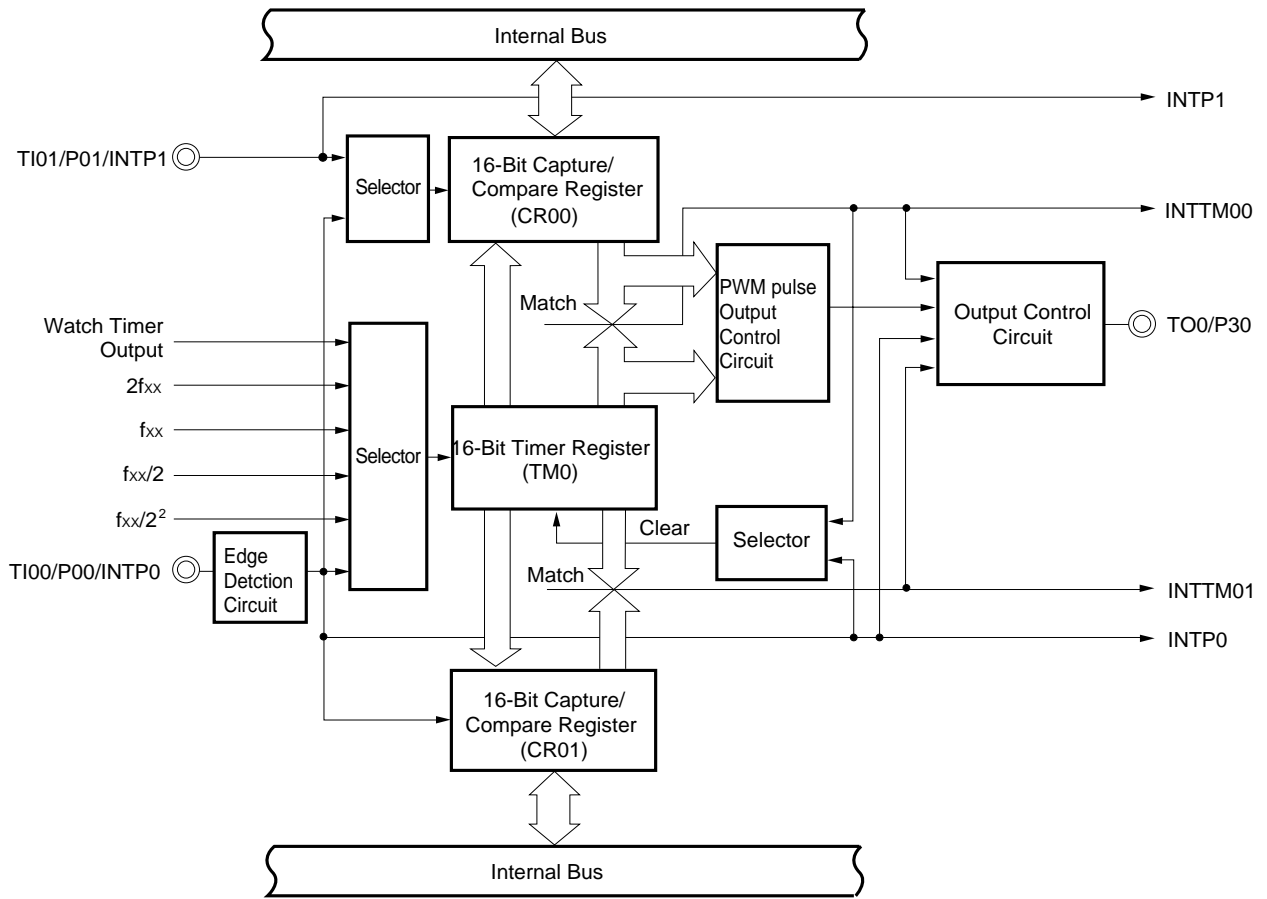
Figure 5-3. 8-Bit Timer/Event Counter Block Diagram

Internal Bus

INTTM1

8-Bit Compare
Register (CR10)

8-Bit Compare
Register (CR20)

Selector

Output
Control
Circuit

TO2/P32

Match

Match

INTTM2

$f_{xx}/2$-$f_{xx}/2^9$

$f_{xx}/2^{11}$

TI1/P33

Selector

8-Bit Timer
Register 1 (TM1)

Selector

8-Bit Timer
Register 2 (TM2)

Clear

Clear

$f_{xx}/2$-$f_{xx}/2^9$

$f_{xx}/2^{11}$

TI2/P34

Selector

Selector

Output
Control
Circuit

TO1/P31

Internal Bus
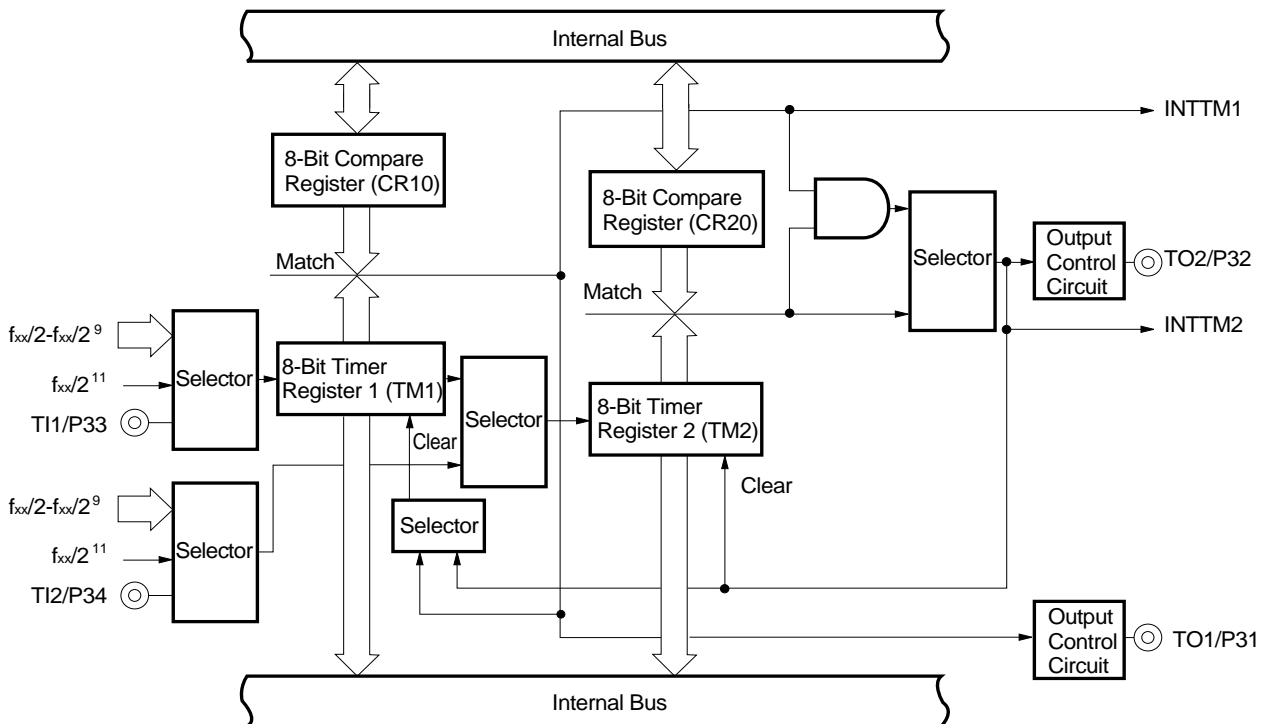
21

Phase-out/Discontinued

Figure 5-4. Watch Timer Block Diagram
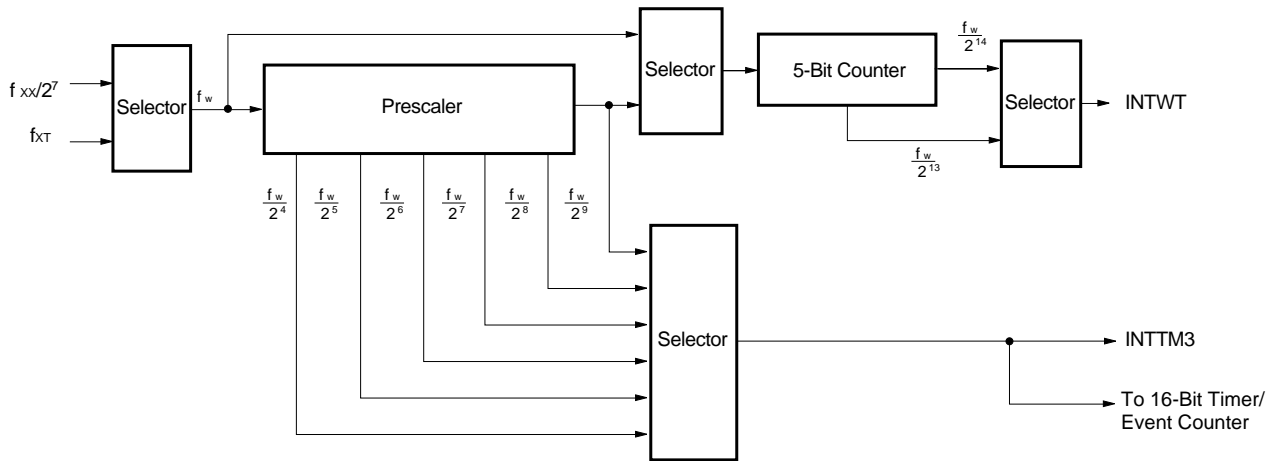
Figure 5-5. Watchdog Timer Block Diagram
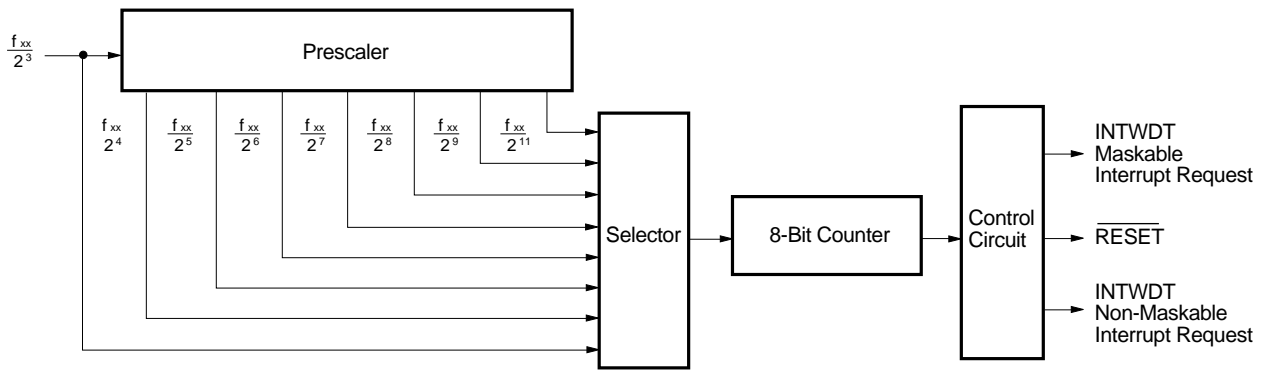
5.4 Clock Output Control Circuit

Clock with the following frequencies can be output as clock output.

* 19.5 kHz/39.1 kHz/78.1 kHz/156 kHz/313 kHz/625 kHz/1.25 MHz/2.5 MHz/5.0 MHz (main system clock: at 5.0-MHz operation)
* 32.768 kHz (subsystem clock: at 32.768-kHz operation)

Figure 5-6. Clock Output Control Block Diagram
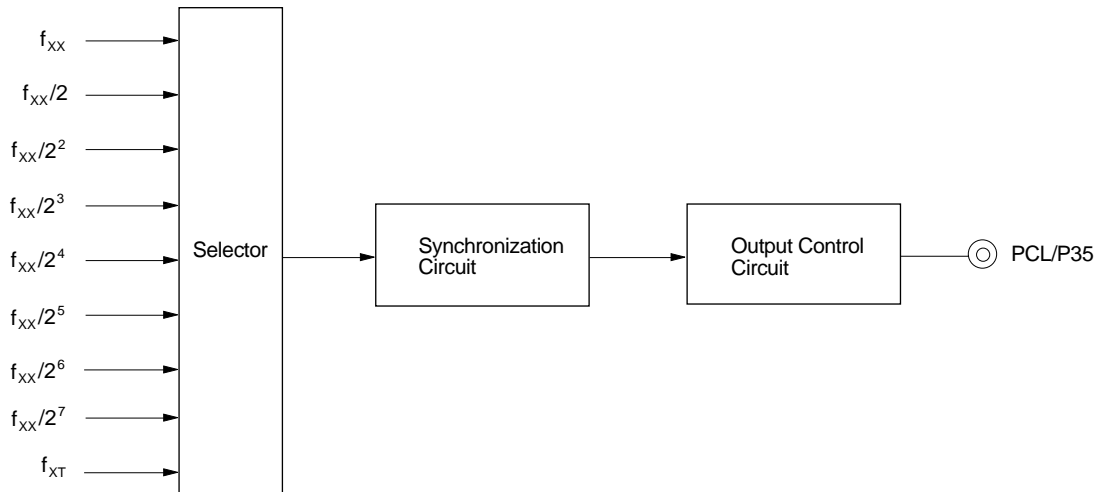
5.5 Buzzer Output Control Circuit

Clock with the following frequencies can be output as buzzer output.

* 1.2 kHz/2.4 kHz/4.9 kHz/9.8 kHz (main system clock: at 5.0-MHz operation)

Figure 5-7. Buzzer Output Control Circuit Block Diagram

Phase-out/Discontinued
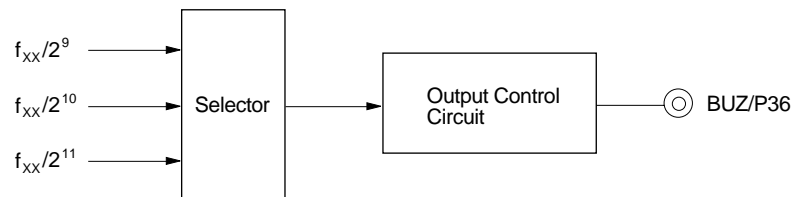
5.6 A/D Converter

An A/D converter of 8-bit resolution × 8 channels is incorporated.

The following two types of A/D conversion operation start-up methods are available.

• Hardware start

• Software start

Figure 5-8. A/D Converter Block Diagram

5.7 D/A Converter

A D/A converter of 8-bit resolution $\times$ 2 channels is available.

The conversion method is the R-2R resistor ladder method.

Figure 5-9. D/A Converter Block Diagram
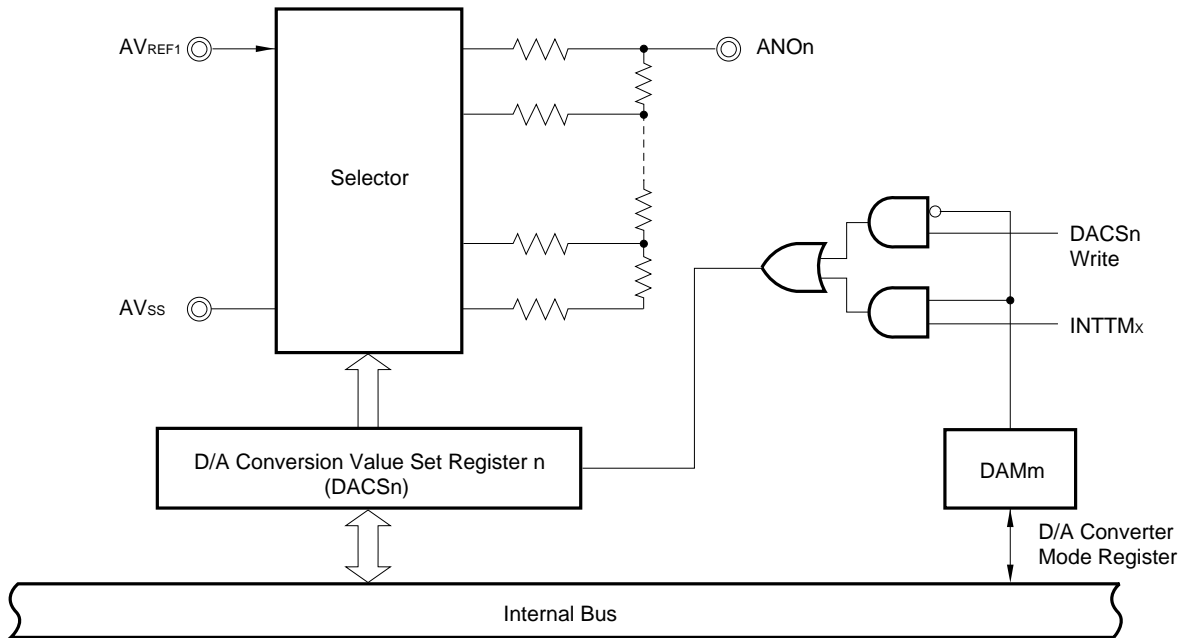
n = 0, 1
m = 4, 5
x = 1, 2

5.8 Serial Interfaces

3 channels of the clocked serial interface are incorporated.

• Serial interface channel 0
• Serial interface channel 1
• Serial interface channel 2

Table 5-3. Types and Functions of Serial Interface

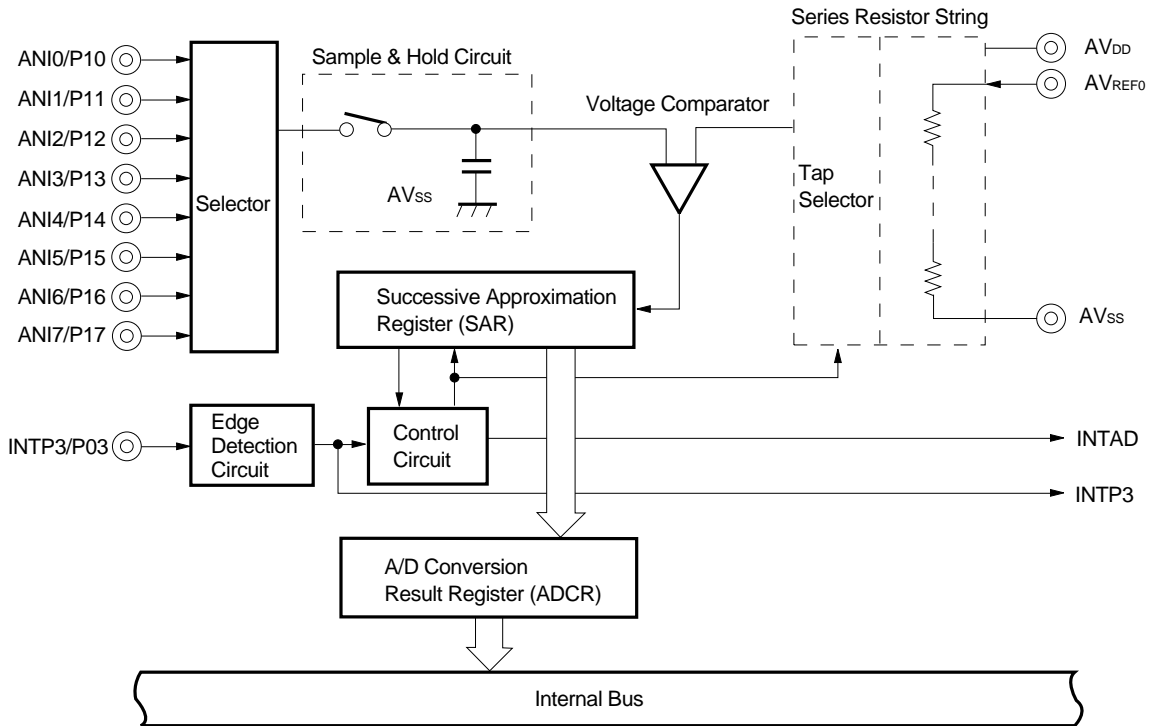| Function	Serial Interface Channel 0	Serial Interface Channel 1	Serial Interface Channel 2
3-wire serial I/O mode	○ (MSB/LSB first switchable)	○ (MSB/LSB first switchable)	○ (MSB/LSB first switchable)
3-wire serial I/O mode with automatic transmission/reception function	—	○ (MSB/LSB first switchable)	—
2-wire serial I/O mode	○ (MSB first)	—	—
I²C bus mode	○ (MSB first)	—	—
Asynchronous serial interface (UART) mode	—	—	○ (Dedicated baud rate generator incorporated)

Phase-out/Discontinued

Figure 5-10. Serial Interface Channel 0 Block Diagram
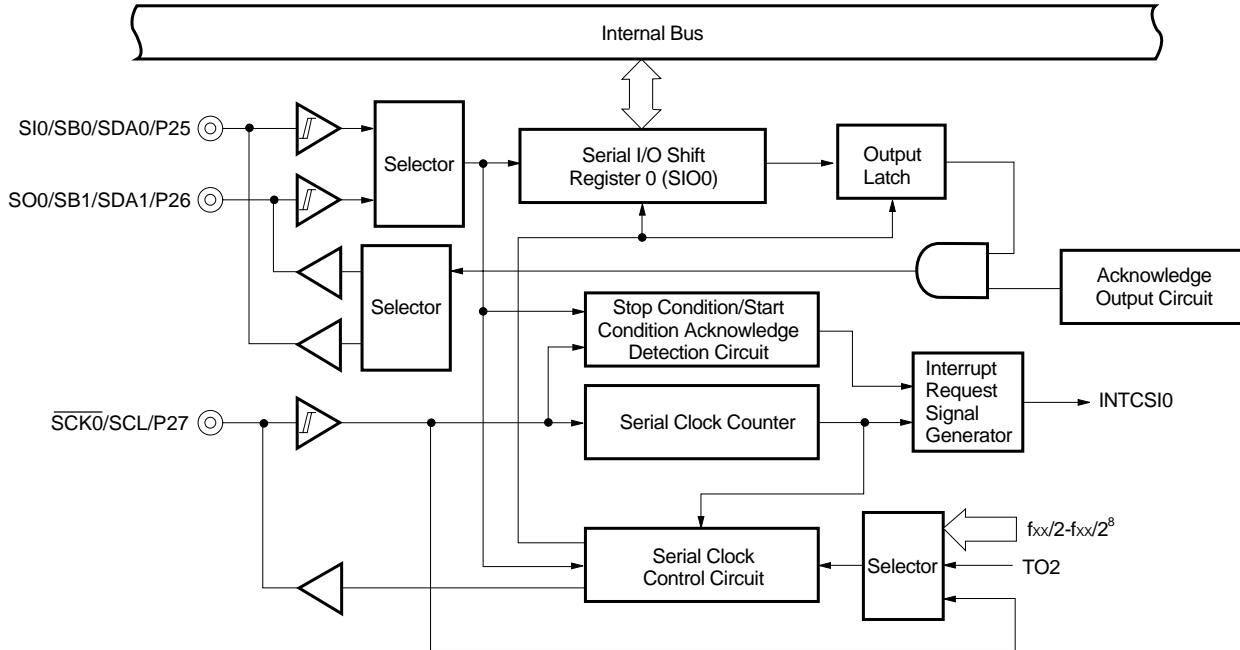
Figure 5-11. Serial Interface Channel 1 Block Diagram
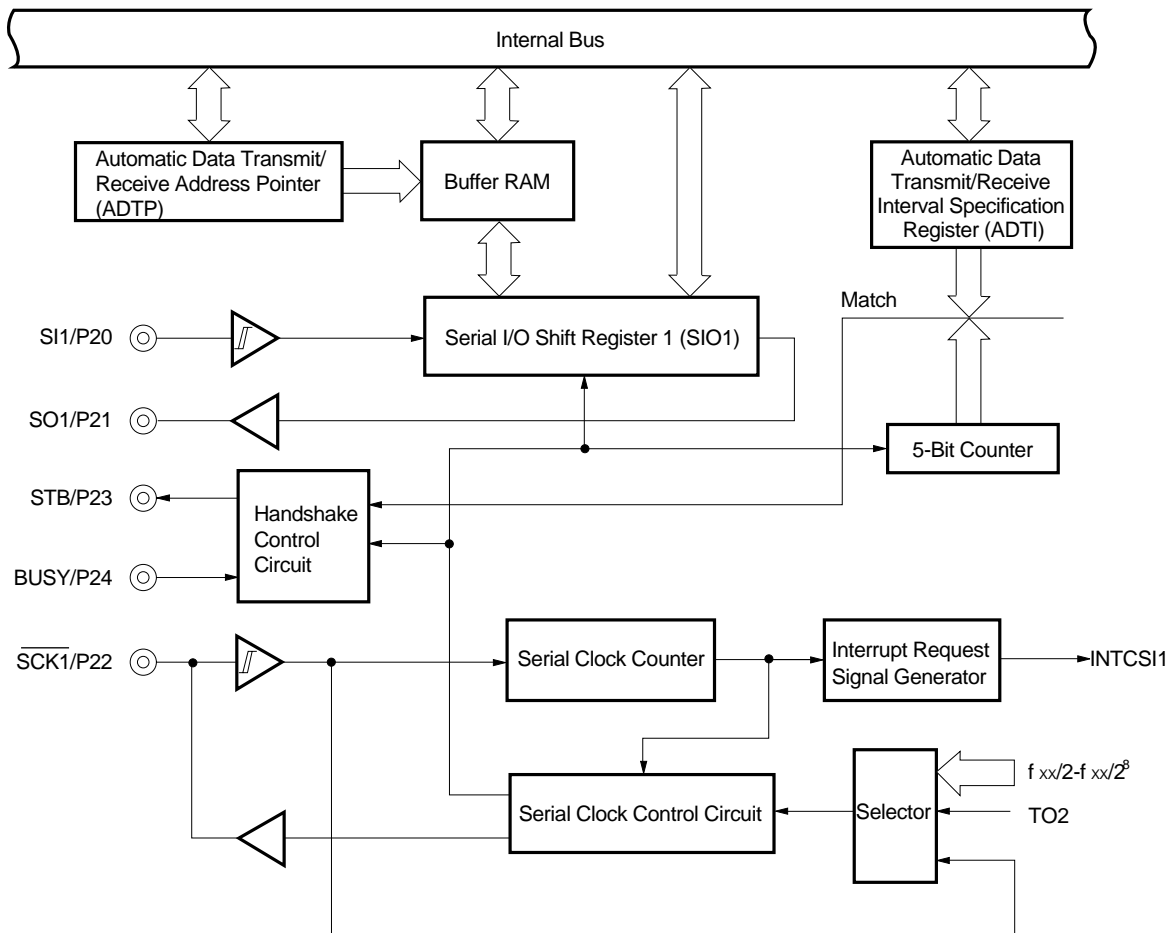
Figure 5-12. Serial Interface Channel 2 Block Diagram
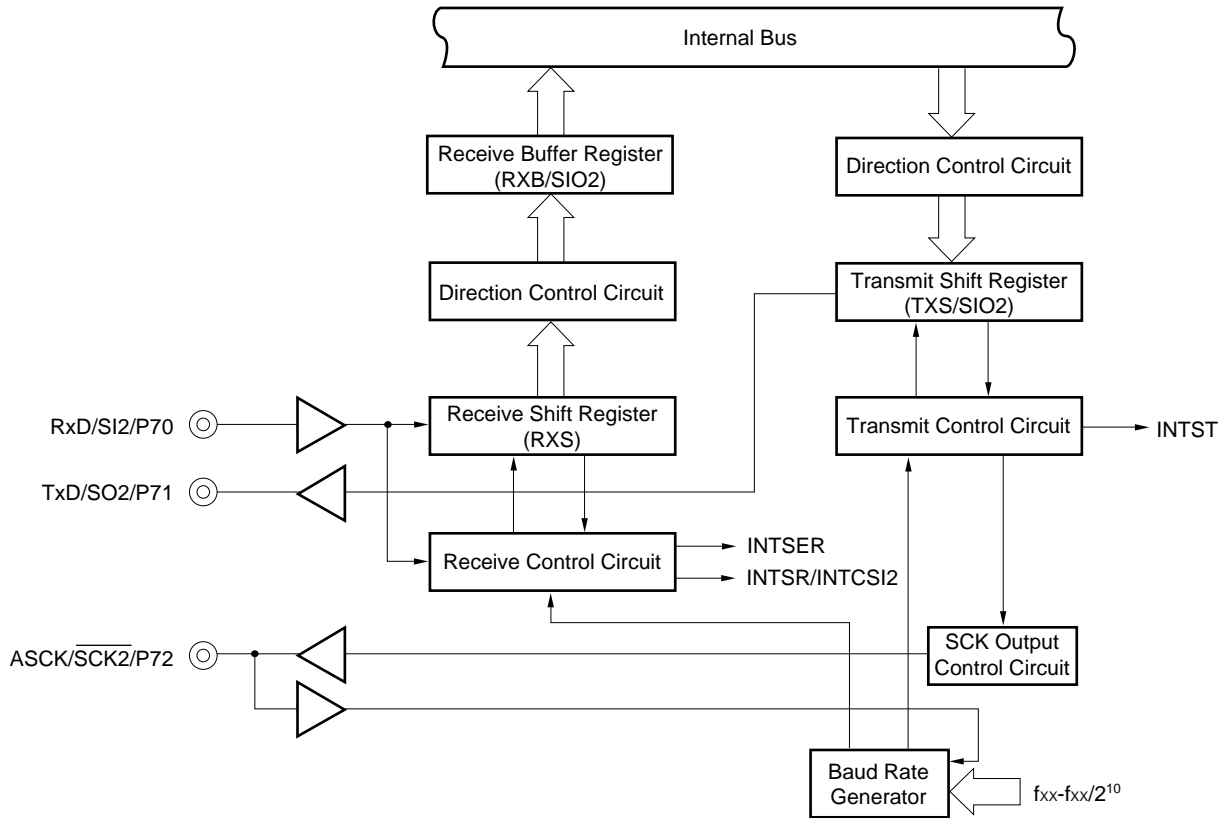
5.9 Real-Time Output Port Functions

Data set previously in the real-time output buffer register is transferred to the output latch by hardware concurrently with timer interrupt request and external interrupt request generation in order to output to off-chip. This is a real-time output function. Pins to output to off-chip are called real-time output ports.

By using a real-time output port, a signal which has no jitter can be output. This is most applicable to control of stepping motors, etc.

Figure 5-13. Real-Time Output Port Block Diagram
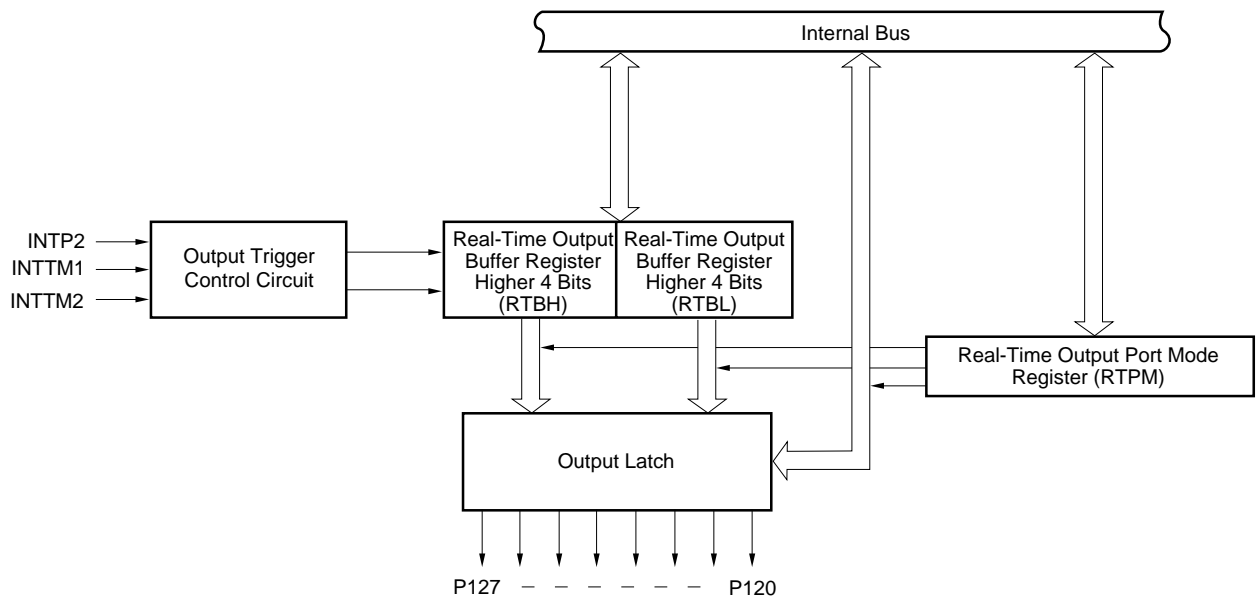
6. INTERRUPT FUNCTIONS AND TEST FUNCTIONS

6.1 Interrupt Functions

There are 22 interrupt functions of 3 different kinds, as shown below.

- Non-maskable : 1
- Maskable : 20
- Software : 1

Table 6-1. Interrupt Source List (1/2)

Interrupt Type	Default Priority [Note 1]	Interrupt Source		Internal/ External	Vector Table Address	Basic Configuration Type [Note 2]
		Name	Trigger			
Non-maskable	——	INTWDT	Watchdog timer overflow (watchdog timer mode 1 selected)	Internal	0004H	(A)
Maskable	0	INTWDT	Watchdog timer overflow (interval timer mode selected)			(B)
	1	INTP0	Pin input edge detection	External	0006H	(C)
	2	INTP1			0008H	(D)
	3	INTP2			000AH	
	4	INTP3			000CH	
	5	INTP4			000EH	
	6	INTP5			0010H	
	7	INTP6			0012H	
	8	INTCSI0	End of serial interface channel 0 transfer	Internal	0014H	(B)
	9	INTCSI1	End of serial interface channel 1 transfer		0016H	
	10	INTSER	Generation of serial interface channel 2 UART receive error		0018H	
	11	INTSR	End of serial interface channel 2 UART reception		001AH	
		INTCSI2	End of serial interface channel 2 3-wire transfer			
	12	INTST	End of serial interface channel 2 UART transmission		001CH	

Notes 1. The default priority is a priority order when two or more maskable interrupt requests are generated simultaneously. 0 is the highest order and 18, the lowest.
2. Basic configuration types (A) to (E) correspond to (A) to (E) in Figure 6-1, respectively.

Table 6-1. Interrupt Source List (2/2)

Interrupt Type	Default Priority [Note 1]	Interrupt Source		Internal/ External	Vector Table Address	Basic Configuration Type [Note 2]
		Name	Trigger			
Maskable	13	INTTM3	Reference time interval signal from watch timer	Internal	001EH	(B)
	14	INTTM00	Generation of match signal of 16-bit timer register and capture/compare register (CR00)		0020H	
	15	INTTM01	Generation of match signal of 16-bit timer register and capture/compare register (CR01)		0022H	
	16	INTTM1	Generation of match signal of 8-bit timer/event counter 1		0024H	
	17	INTTM2	Generation of match signal of 8-bit timer/event counter 2		0026H	
	18	INTAD	End of conversion by A/D converter		0028H	
Software	—	BRK	BRK instruction execution	—	003EH	(E)

Notes 1. The default priority is a priority order when two or more maskable interrupt requests are generated simultaneously. 0 is the highest order and 18, the lowest.
2. Basic configuration types (A) to (E) correspond to (A) to (E) in Figure 6-1, respectively.
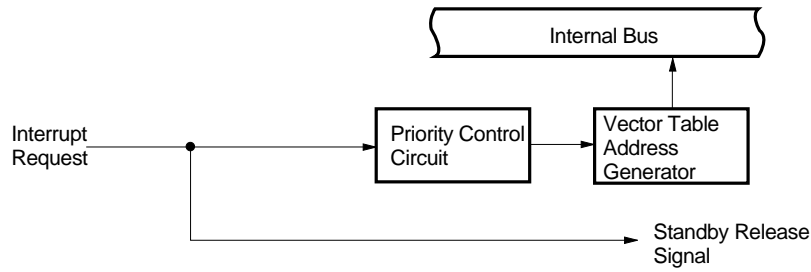
Figure 6-1. Interrupt Function Basic Configuration (1/2)

(A) Internal non-maskable interrupt

(B) Internal maskable interrupt
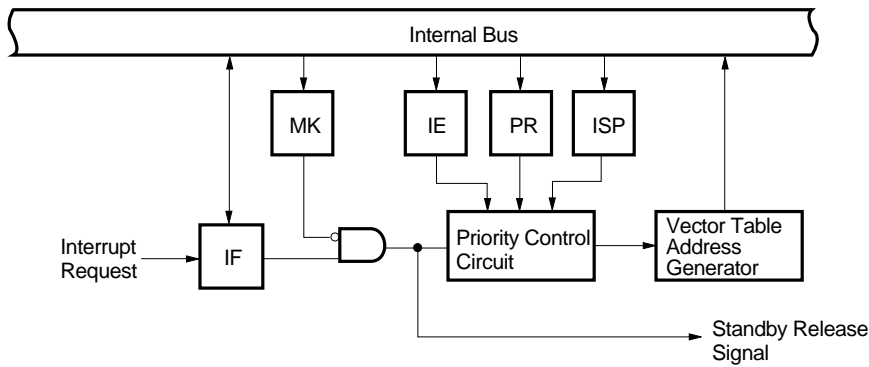
(C) External maskable interrupt (INTP0)
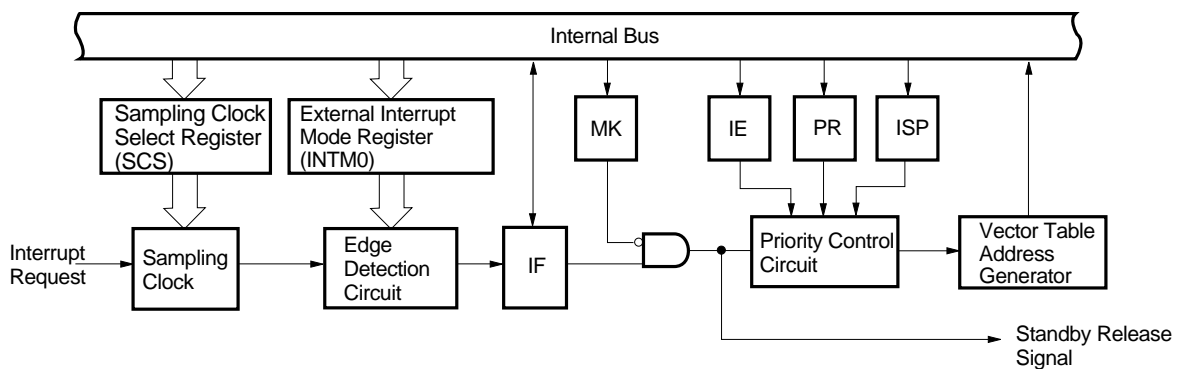
Figure 6-1. Interrupt Function Basic Configuration (2/2)

(D) External maskable interrupt (except INTP0)
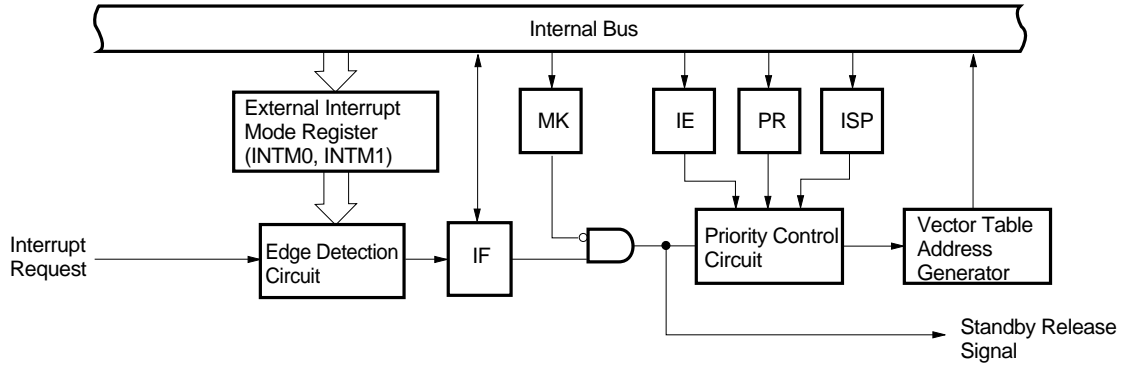
(E) Software interrupt
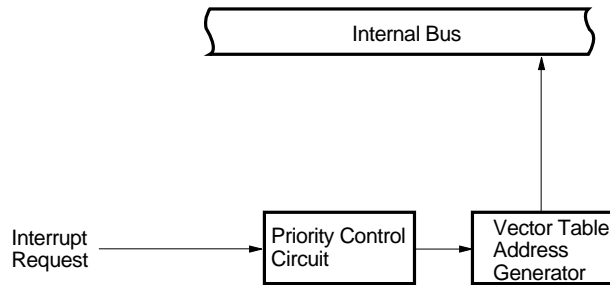
IF : Interrupt request flag

IE : Interrupt enable flag

ISP : In-service priority flag

MK : Interrupt mask flag

PR : Priority specification flag

6.2 Test Functions

There are two test functions as shown in Table 6-2.

Table 6-2. Test Input Source List

Test Input Source		Internal/External
Name	Trigger	
INTWT	Watch timer overflow	Internal
INTPT4	Port 4 falling edge detection	External

Figure 6-2. Test Function Basic Configuration
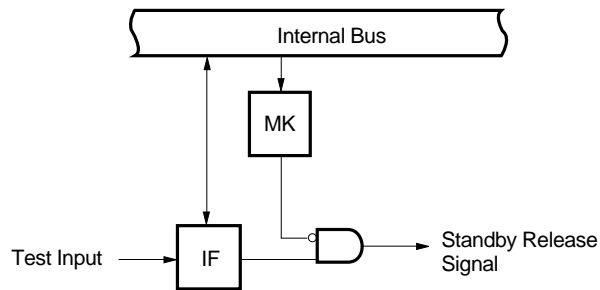
IF : Test input flag
MK : Test mask flag

7. EXTERNAL DEVICE EXPANSION FUNCTIONS

The external device expansion functions connect external devices to areas other than the internal ROM, RAM and SFR. Ports 4 to 6 are used for external device connection.

8. STANDBY FUNCTION

There are the following two standby functions to reduce the system power consumption.

- HALT mode   : The CPU operating clock is stopped.
The average consumption current can be reduced by intermittent operation in combination with the normal operating mode.
- STOP mode   : The main system clock oscillation is stopped. The whole operation by the main system clock is stopped, so that the system operates with ultra-low power consumption using only the subsystem clock.

Figure 8-1. Stand-by Function
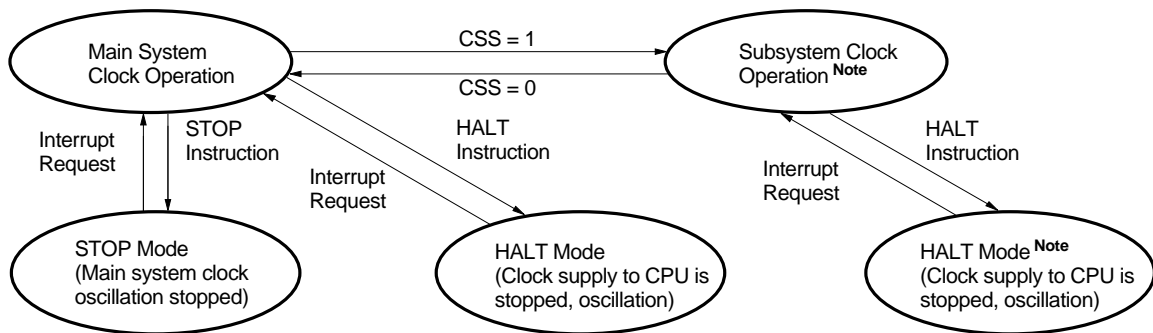
Note   The power consumption can be reduced by stopping the main system clock. When the CPU is operating on the subsystem clock, set bit 7 (MCC) in the processor clock control register (PCC) to stop the main system clock. The STOP instruction cannot be used.

Caution   **When the main system clock is stopped and the system is operated by the subsystem clock, the subsystem clock should be switched again to the main system clock after the oscillation stabilization time is secured by the program.**

Remark   CSS : bit 4 in the PCC

9. RESET FUNCTION

There are the following two reset methods.
- External reset input by $\overline{\text{RESET}}$ pin
- Internal reset by watchdog time runaway time detection

10. INSTRUCTION SET

(1) 8-bit instructions

MOV, XCH, ADD ADDC, SUB, SUBC, AND, OR, XOR, CMP, MULU, DIVUW, INC, DEC, ROR, ROL, RORC, ROLC, ROR4, ROL4, PUSH, POP, DBNZ

Second Operand / First Operand	#byte	A	r Note	sfr	saddr	!addr16	PSW	[DE]	[HL]	[HL + Byte] [HL + B] [HL + C]	$addr16	1	None
A	ADD ADDC SUB SUBC AND OR XOR CMP		MOV XCH ADD ADDC SUB SUBC AND OR XOR CMP	MOV XCH	MOV XCH ADD ADDC SUB SUBC AND OR XOR CMP	MOV XCH ADD ADDC SUB SUBC AND OR XOR CMP	MOV	MOV XCH	MOV XCH ADD ADDC SUB SUBC AND OR XOR CMP	MOV XCH ADD ADDC SUB SUBC AND OR XOR CMP		ROR ROL RORC ROLC	
r	MOV	MOV ADD ADDC SUB SUBC AND OR XOR CMP											INC DEC
B, C											DBNZ		
sfr	MOV	MOV											
saddr	MOV ADD ADDC SUB SUBC AND OR XOR CMP	MOV									DBNZ		INC DEC
!addr16		MOV											
PSW	MOV	MOV											PUSH POP
[DE]		MOV											
[HL]		MOV											ROR4 ROL4
[HL + Byte] [HL + B] [HL + C]		MOV											
X													MULU
C													DIVUW

Note Except r = A

Phase-out/Discontinued

(2) 16-bit instructions

MOVW, XCHW, ADDW, SUBW, CMPW, PUSH, POP, INCW, DECW

Second Operand / First Operand	#word	AX	rp Note	sfrp	saddrp	!addr16	SP	None
AX	ADDW SUBW CMPW		MOVW XCHW	MOVW	MOVW	MOVW	MOVW	
rp	MOVW	MOVW Note						INCW, DECW PUSH, POP
sfrp	MOVW	MOVW						
saddrp	MOVW	MOVW						
!addr16		MOVW						
SP	MOVW	MOVW						

Note Only when rp = BC, DE or HL

(3) Bit manipulation instructions

MOV1, AND1, OR1, XOR1, SET1, CLR1, NOT1, BT, BF, BTCLR

Second Operand / First Operand	A.bit	sfr.bit	saddr.bit	PSW.bit	[HL].bit	CY	$addr16	None
A.bit						MOV1	BT BF BTCLR	SET1 CLR1
sfr.bit						MOV1	BT BF BTCLR	SET1 CLR1
saddr.bit						MOV1	BT BF BTCLR	SET1 CLR1
PSW.bit						MOV1	BT BF BTCLR	SET1 CLR1
[HL].bit						MOV1	BT BF BTCLR	SET1 CLR1
CY	MOV1 AND1 OR1 XOR1	MOV1 AND1 OR1 XOR1	MOV1 AND1 OR1 XOR1	MOV1 AND1 OR1 XOR1	MOV1 AND1 OR1 XOR1			SET1 CLR1 NOT1

(4) Call instruction/branch instructions

CALL, CALLF, CALLT, BR, BC, BNC, BZ, BNZ, BT, BF, BTCLR, DBNZ

Second Operand / First Operand	AX	!addr16	!addr11	[addr5]	$addr16
Basic instruction	BR	CALL BR	CALLF	CALLT	BR, BC, BNC BZ, BNZ
Compound instruction					BT, BF BTCLR DBNZ

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(5) Other instructions

ADJBA, ADJBS, BRK, RET, RETI, RETB, SEL, NOP, EI, DI, HALT, STOP

11. ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings ($T_A = 25°C$)

Parameter	Symbol	Test Conditions		Rating	Unit
Supply voltage	V_{DD}			−0.3 to + 7.0	V
	AV_{DD}			−0.3 to V_{DD} + 0.3	V
	AV_{REF0}			−0.3 to V_{DD} + 0.3	V
	AV_{REF1}			−0.3 to V_{DD} + 0.3	V
	AV_{SS}			−0.3 to + 0.3	V
Input voltage	V_{I1}	P00 to P07, P10 to P17,P20 to P27, P30 toP37, P40 to P47, P50 to P57, P64 to P67, P70 to P72, P120 to P127, P130, P131, X1, X2, XT2 $\overline{RESET}$		−0.3 to V_{DD} + 0.3	V
	V_{I2}	P60 to P63	N-ch Open-drain	−0.3 to +16	V
Output voltage	V_O			−0.3 to V_{DD} + 0.3	V
Analog input voltage	V_{AN}	P10 to P17	Analog input pin	AV_{SS} −0.3 to AV_{REF0} + 0.3	V
High level output current	I_{OH}	1 pin		−10	mA
		P01 to P06, P30-P37, P56, P57, P60 to P67, P120 to P127 total		−15	mA
		P10 to P17, P20 to P27, P40 to P47, P50 to P55, P70 to P72, P130, P131 total		−15	mA
Low level output current	I_{OL} **Note**	1 pin	Peak value	30	mA
			Effective value	15	mA
		P50 to P55 total	Peak value	100	mA
			Effective value	70	mA
		P56, P57, P60 to P63 total	Peak value	100	mA
			Effective value	70	mA
		P10 to P17, P20 to P27, P40 to P47, P70 to P72, P130, P131 total	Peak value	50	mA
			Effective value	20	mA
		P01 to P06, P30 to P37, P64 to P67, P120 to P127 total	Peak value	50	mA
			Effective value	20	mA
Operating ambient temperature	T_A			−40 to +85	°C
Storage temperature	T_{stg}			−65 to +150	°C

Note The effective value should be calculated as follows: [Effective value] = [Peak value] $\times \sqrt{duty}$

Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

Remark Unless specified otherwise, alternate-function pin characteristics are the same as port pin characteristics.

Main System Clock Oscillation Circuit Characteristics (T$_A$ = –40 to 85°C, V$_{DD}$ = 2.7 to 6.0 V)

Resonator	Recommended Circuit	Parameter	Test Conditions	MIN.	TYP.	MAX.	Unit
Ceramic resonator	X2 X1 IC C2 C1	Oscillator frequency (f$_X$) **Note 1**	V$_{DD}$ = Oscillator voltage range	1.0		5.0	MHz
		Oscillation stabilization time **Note 2**	After V$_{DD}$ reaches oscillator voltage range MIN.			4	ms
Crystal resonator	X2 X1 IC C2 C1	Oscillator frequency (f$_X$) **Note 1**		1.0		5.0	MHz
		Oscillation stabilization time **Note 2**	V$_{DD}$ = 4.5 to 6.0 V			10	ms
						30	
External clock	X2 X1 μPD74HCU04	X1 input frequency (f$_X$) **Note 1**		1.0		5.0	MHz
		X1 input high/low level width (t$_{XH}$, t$_{XL}$)		85		500	ns

Notes 1. Indicates only oscillation circuit characteristics. Refer to "AC Characteristics" for instruction execution time.
     2. Time required to stabilize oscillation after reset or STOP mode release.

Cautions   1. When using the main system clock oscillator, wiring in the area enclosed with the broken line in the above figures should be carried out as follows to avoid an adverse effect from wiring capacitance.

- **Wiring should be as short as possible.**
- **Wiring should not cross other signal lines.**
- **Wiring should not be placed close to a varying high current.**
- **The potential of the oscillator capacitor ground should be the same as V$_{SS}$.**
- **Do not ground wiring to a ground pattern in which a high current flows.**
- **Do not fetch a signal from the oscillator.**

**   2. When the main system clock is stopped and the system is operated by the subsystem clock, the subsystem clock should be switched again to the main system clock after the oscillation stabilization time is secured by the program.**

Subsystem Clock Oscillation Circuit Characteristics (T$_A$ = –40 to +85°C, V$_{DD}$ = 2.7 to 6.0 V)

Resonator	Recommended Circuit	Parameter	Test Conditions	MIN.	TYP.	MAX.	Unit
Crystal resonator	IC XT2 XT1 R1 C4 C3	Oscillator frequency (f$_{XT}$) **Note 1**		32	32.768	35	kHz
		Oscillation stabilization time **Note 2**	V$_{DD}$ = 4.5 to 6.0 V		1.2	2	s
						10	
External clock	XT2 XT1	XT1 input frequency (f$_{XT}$) **Note 1**		32		100	kHz
		XT1 input high-/low-level width (t$_{XTH}$, t$_{XTL}$)		5		15	μs

Notes 1. Indicates only oscillation circuit characteristics. Refer to "AC Characteristics" for instruction execution time.
 2. Time required to stabilize oscillation after V$_{DD}$ reaches oscillator voltage MIN.

Cautions 1. When using the subsystem clock oscillator, wiring in the area enclosed with the broken line in the above figures should be carried out as follows to avoid an adverse effect from wiring capacitance.

 • **Wiring should be as short as possible.**
 • **Wiring should not cross other signal lines.**
 • **Wiring should not be placed close to a varying high current.**
 • **The potential of the oscillator capacitor ground should be the same as V$_{SS}$.**
 • **Do not ground wiring to a ground pattern in which a high current flows.**
 • **Do not fetch a signal from the oscillator.**

 2. The subsystem clock oscillator is a low-amplitude circuit in order to achieve a low consumption current, and is more prone to malfunction due to noise than the main system clock oscillator. Particular care is therefore required with the wiring method when the subsystem clock is used.

Capacitance (T$_A$ = 25°C, V$_{DD}$ = V$_{SS}$ = 0 V)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
Input capacitance	C$_{IN}$	f = 1 MHz Measured pins returned to 0 V.				15	pF
I/O capacitance	C$_{IO}$	f = 1 MHz Measured pins returned to 0 V.	P01 to P06, P10 to P17, P20 to P27, P30 to P37, P40 to P47, P50 to P57, P64 to P67, P70 to P72, P120 to P127, P130, P131			15	pF
			P60 to P63			20	pF

Remark The characteristics of the alternate-function pins are the same as those of the port pins unless otherwise specified.

DC Characteristics (T$_A$ = –40 to +85°C, V$_{DD}$ = 2.7 to 6.0 V)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
Input voltage, high	V$_{IH1}$	P10 to P17, P21, P23, P30 to P32, P35 to P37, P40 to P47, P50 to P57, P64 to P67, P71, P120 to P127, P130, P131		0.7 V$_{DD}$		V$_{DD}$	V
	V$_{IH2}$	P00 to P06, P20, P22, P24 to P27, P33, P34, P70, P72, $\overline{RESET}$		0.8 V$_{DD}$		V$_{DD}$	V
	V$_{IH3}$	P60 to P63 (N-ch Open-drain)		0.7 V$_{DD}$		15	V
	V$_{IH4}$	X1, X2		V$_{DD}$–0.5		V$_{DD}$	V
	V$_{IH5}$	XT1/P07, XT2	V$_{DD}$ = 4.5 to 6.0 V	0.8 V$_{DD}$		V$_{DD}$	V
				0.9 V$_{DD}$		V$_{DD}$	V
Input voltage, low	V$_{IL1}$	P10 to P17, P21, P23, P30 to P32, P35 to P37, P40 to P47, P50 to P57, P64 to P67, P71, P120 to P127, P130, P131		0		0.3 V$_{DD}$	V
	V$_{IL2}$	P00 to P06, P20, P22, P24 to P27, P33, P34, P70, P72, $\overline{RESET}$		0		0.2 V$_{DD}$	V
	V$_{IL3}$	P60 to P63	V$_{DD}$ = 4.5 to 6.0 V	0		0.3 V$_{DD}$	V
				0		0.2 V$_{DD}$	V
	V$_{IL4}$	X1, X2		0		0.4	V
	V$_{IL5}$	XT1/P07, XT2	V$_{DD}$ = 4.5 to 6.0 V	0		0.2 V$_{DD}$	V
				0		0.1 V$_{DD}$	V
Output voltage, high	V$_{OH}$	V$_{DD}$ = 4.5 to 6.0 V, I$_{OH}$ = –1mA		V$_{DD}$–1.0			V
		I$_{OH}$ = –100 μA		V$_{DD}$–0.5			V
Output voltage, low	V$_{OL1}$	P50 to P57, P60 to P63	V$_{DD}$ = 4.5 to 6.0 V, I$_{OL}$ = 15 mA		0.4	2.0	V
		P01 to P06, P10 to P17, P20 to P27, P30 to P37, P40 to P47, P64 to P67, P70 to P72, P120 to P127, P130, P131	V$_{DD}$ = 4.5 to 6.0 V, I$_{OL}$ = 1.6 mA			0.4	V
	V$_{OL2}$	SB0, SB1, $\overline{SCK0}$	V$_{DD}$ = 4.5 to 6.0 V, N-ch open-drain at pull-up time(R = 1 kΩ)			0.2 V$_{DD}$	V
	V$_{OL3}$	I$_{OL}$ = 400 μA				0.5	V
Input leakage current, high	I$_{LIH1}$	V$_{IN}$ = V$_{DD}$	P00 to P06, P10 to P17, P20 to P27, P30 to P37, P40 to P47, P50 to P57, P60 to P67, P70 to P72, P120 to P127, P130, P131 $\overline{RESET}$			3	μA
	I$_{LIH2}$		X1, X2, XT1/P07, XT2			20	μA
	I$_{LIH3}$	V$_{IN}$ = 15 V	P60 to P63			80	μA

Remark The characteristics of alternate-function pins and a port pin are the same unless specified otherwise.

DC Characteristics (T$_A$ = −40 to +85°C, V$_{DD}$ = 2.7 to 6.0 V)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
Input leakage current, low	I$_{LIL1}$	V$_{IN}$ = 0 V	P00 to P06, P10 to P17, P20 to P27, P30 to P37, P40 to P47, P50 to P57, P64 to P67, P70 to P72, P120 to P127, P130, P131, $\overline{\text{RESET}}$			−3	μA
	I$_{LIL2}$		X1, X2, XT1/P07, XT2			−20	μA
	I$_{LIL3}$		P60 to P63			−3 **Note**	μA
Output leakage current, high	I$_{LOH}$	V$_{OUT}$ = V$_{DD}$				3	μA
Output leakage current, low	I$_{LOL}$	V$_{OUT}$ = 0 V				−3	μA
Mask option pull-up resistor	R$_1$	V$_{IN}$ = 0 V, P60 to P63		20	40	90	kΩ
Software pull-up resistor	R$_2$	V$_{IN}$ = 0 V, P01 to P06, P10 to P17, P20 to P27, P30 to P37, P40 to P47, P50 to P57, P64 to P67, P70 to P72, P120 to P127, P130, P131	V$_{DD}$ = 4.5 V to 6.0 V	15	40	90	kΩ
				20		500	kΩ

Note When the pull-up resistor is not included in P60 to P63 (specified by a mask option), a −200 μA (MAX.) low-level input leakage current flows only at the 1.5 clock interval (no wait) when the read instruction to port 6 (PM6) and port mode register (PM6) is executed. At times other than this 1.5 interval, a −3 μA (MAX.) curent flows.

Remark The characteristics of alternate-function pins and port pins are the same unless specified otherwise.

DC Characteristics (T$_A$ = –40 to +85°C, V$_{DD}$ = 2.7 to 6.0 V)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
Power supply current Note 1	I$_{DD1}$	5.0-MHz crystal oscillation operating mode (f$_{XX}$ = 2.5 MHz) Note 2	V$_{DD}$ = 5.0 V ± 10% Note 5		4	12	mA
			V$_{DD}$ = 3.0 V ± 10% Note 6		0.6	1.8	mA
		5.0-MHz crystal oscillation operating mode (f$_{XX}$ = 5.0 MHz) Note 3	V$_{DD}$ = 5.0 V ± 10% Note 5		6.5	19.5	mA
			V$_{DD}$ = 3.0 V ± 10% Note 6		0.8	2.4	mA
	I$_{DD2}$	5.0-MHz crystal oscillation HALT mode (f$_{XX}$ = 2.5 MHz) Note 2	V$_{DD}$ = 5.0 V ± 10%		1.4	4.2	mA
			V$_{DD}$ = 3.0 V ± 10%		0.5	1.5	mA
		5.0-MHz crystal oscillation HALT mode (f$_{XX}$ = 5.0 MHz) Note 3	V$_{DD}$ = 5.0 V ± 10%		1.6	4.8	mA
			V$_{DD}$ = 3.0 V ± 10%		0.65	1.95	mA
	I$_{DD3}$	32.768-kHz crystal oscillation operating mode Note 4	V$_{DD}$ = 5.0 V ± 10%		60	120	μA
			V$_{DD}$ = 3.0 V ± 10%		32	64	μA
	I$_{DD4}$	32.768-kHz crystal oscillation HALT mode Note 4	V$_{DD}$ = 5.0 V ± 10%		25	55	μA
			V$_{DD}$ = 3.0 V ± 10%		5	15	μA
	I$_{DD5}$	XT1 = V$_{DD}$ STOP mode When feedback resistor is used	V$_{DD}$ = 5.0 V ± 10%		1	30	μA
			V$_{DD}$ = 3.0 V ± 10%		0.5	10	μA
	I$_{DD6}$	XT1 = V$_{DD}$ STOP mode When feedback resistor is not used	V$_{DD}$ = 5.0 V ± 10%		0.1	30	μA
			V$_{DD}$ = 3.0 V ± 10%		0.05	10	μA

Notes 1. Flows through the V$_{DD}$ and AV$_{DD}$ pins. Does not include the current which flows through the A/D converter, D/A converter, and on-chip pull-up resistor.

    2. f$_{XX}$ = f$_X$/2 operation (when oscillation mode selection register (OSMS) is set to 00H)

    3. f$_{XX}$ = f$_X$ operation (when the OSMS is set to 01H)

    4. When the main system clock is stopped

    5. High-speed mode operation (when a processor clock control register (PCC) is set to 00H)

    6. Low-speed mode operation (when the PCC is set to 04H)

Remarks 1. f$_{XX}$: Main system clock frequency (f$_X$ or f$_X$/2)

    2. f$_X$: Main system clock oscillator frequency

AC CHARACTERISTICS

(1) Basic Operation (T_A = –40 to +85°C, V_DD = 2.7 to 6.0 V)

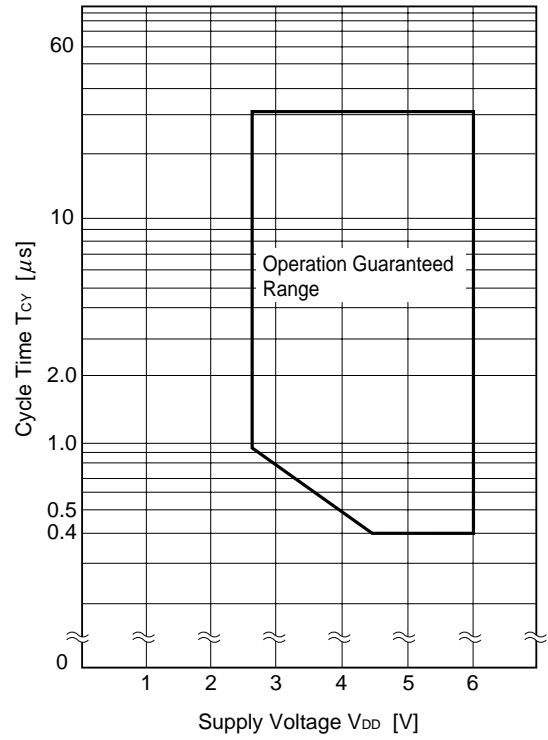| Parameter	Symbol	Test Conditions			MIN.	TYP.	MAX.	Unit
Cycle time (Min. instruction execution time)	T_{CY}	Operating on main system clock	$f_{XX} = f_X/2$ [Note 1]		0.8		64	μs
			$f_{XX} = f_X$ [Note 2]	V_{DD} = 4.5 to 6.0 V	0.4		32	μs
					0.8		32	μs
		Operating on subsystem clock			40	122	125	μs
TI00 input high-/low-level width	t_{TIH00}, t_{TIL00}	V_{DD} = 4.5 to 6.0 V			$2/f_{sam}+0.1$ [Note 3]			μs
					$2/f_{sam}+0.2$ [Note 3]			μs
TI01 input high-/low-level width	t_{TIH01}, t_{TIL01}				10			μs
TI1, TI2 input frequency	f_{TI1}	V_{DD} = 4.5 to 6.0 V			0		4	MHz
					0		275	kHz
TI1, TI2 input high-/low-level width	t_{TIH1}, t_{TIL1}	V_{DD} = 4.5 to 6.0 V			100			ns
					1.8			μs
Interrupt request input high-/low-level width	t_{INTH}, t_{INTL}	INTP0		V_{DD} = 4.5 to 6.0 V	$2/f_{sam}+0.1$ [Note 3]			μs
					$2/f_{sam}+0.2$ [Note 3]			μs
		INTP1 to INTP6, KR0 to KR7			10			μs
RESET low-level width	t_{RSL}				10			μs

Notes 1. When oscillation mode selection register is set to 00H

2. When oscillation mode selection register is set to 01H

3. In combination with bits 0 (SCS0) and 1 (SCS1) of sampling clock select register (SCS), selection of f_{sam} is possible between $f_{XX}/2^N$, $f_{XX}/32$, $f_{XX}/64$ and $f_{XX}/128$ (when N= 0 to 4).

Remarks 1. f_{XX}: Main system clock frequency (f_X or $f_X/2$)

2. f_X: Main system clock oscillation frequency

T_{CY} vs V_{DD} (at f_{XX} = f_X/2 main system clock operation)
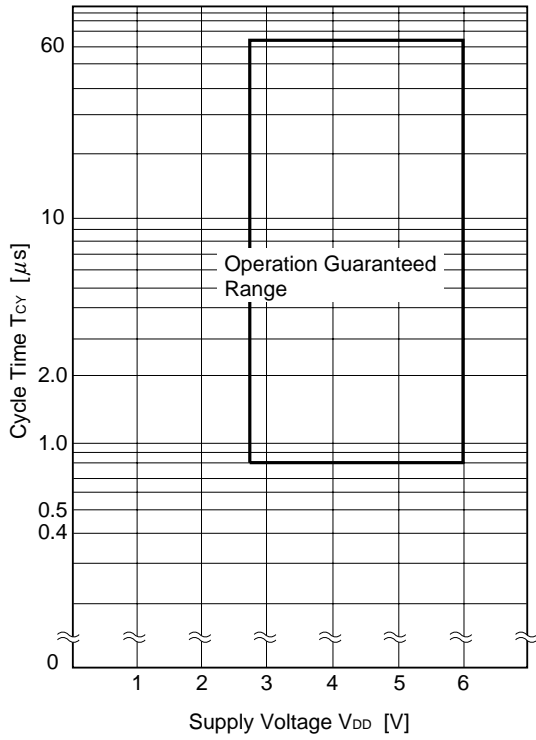
T_{CY} vs V_{DD} (at f_{XX} = f_X main system clock operation)

(2) Read/Write Operation

(a) When MCS = 1, PCC2 to PCC0 = 000B (T$_A$ = –40 to + 85°C, V$_{DD}$ = 4.5 to 6.0 V)

Parameter	Symbol	Test Conditions	MIN.	MAX.	Unit
ASTB high-level width	t$_{ASTH}$		0.85t$_{CY}$ – 50		ns
Address setup time	t$_{ADS}$		0.85t$_{CY}$ – 50		ns
Address hold time	t$_{ADH}$		50		ns
Data input time from address	t$_{ADD1}$			(2.85+2n)t$_{CY}$–80	ns
	t$_{ADD2}$			(4+2n)t$_{CY}$–100	ns
Data input time from $\overline{RD}$↓	t$_{RDD1}$			(2+2n)t$_{CY}$–100	ns
	t$_{RDD2}$			(2.85+2n)t$_{CY}$–100	ns
Read data hold time	t$_{RDH}$		0		ns
$\overline{RD}$ low-level width	t$_{RDL1}$		(2+2n)t$_{CY}$–60		ns
	t$_{RDL2}$		(2.85+2n)t$_{CY}$–60		ns
$\overline{WAIT}$↓ input time from $\overline{RD}$↓	t$_{RDWT1}$			0.85t$_{CY}$–50	ns
	t$_{RDWT2}$			2t$_{CY}$–60	ns
$\overline{WAIT}$↓ input time from $\overline{WR}$↓	t$_{WRWT}$			2t$_{CY}$–60	ns
$\overline{WAIT}$ low-level width	t$_{WTL}$		(1.15+2n)t$_{CY}$	(2+2n)t$_{CY}$	ns
Write data setup time	t$_{WDS}$		(2.85+2n)t$_{CY}$–100		ns
Write data hold time	t$_{WDH}$		20		ns
$\overline{WR}$ low-level width	t$_{WRL}$		(2.85+2n)t$_{CY}$–60		ns
$\overline{RD}$↓ delay time from ASTB↓	t$_{ASTRD}$		25		ns
$\overline{WR}$↓ delay time from ASTB↓	t$_{ASTWR}$		0.85t$_{CY}$ + 20		ns
ASTB↑ delay time from $\overline{RD}$↑ in external fetch	t$_{RDAST}$		0.85t$_{CY}$ – 10	1.15t$_{CY}$ + 20	ns
Address hold time from $\overline{RD}$↑ in external fetch	t$_{RDADH}$		0.85t$_{CY}$ – 50	1.15t$_{CY}$ + 50	ns
Write data output time from $\overline{RD}$↑	t$_{RDWD}$		40		ns
Write data output time from $\overline{WR}$↓	t$_{RDWD}$		0	50	ns
Address hold time from $\overline{WR}$↑	t$_{WRADH}$		0.85t$_{CY}$	1.15t$_{CY}$ + 40	ns
$\overline{RD}$↑ delay time from $\overline{WAIT}$↑	t$_{WTRD}$		1.15t$_{CY}$ + 40	3.15t$_{CY}$ + 40	ns
$\overline{WR}$↑ delay time from $\overline{WAIT}$↑	t$_{WTWR}$		1.15t$_{CY}$ + 30	3.15t$_{CY}$+ 30	ns

Remarks 1. MCS: Oscillation mode selection register (OSMS) bit 0

2. PCC2 to PCC0: Processor clock control register (PCC) bit 2 to bit 0

3. t$_{CY}$ = T$_{CY}$/4

4. n indicates the number of waits.

(b) Except when MCS = 1, PCC2 to PCC0 = 000B (T$_A$ = −40 to + 85°C, V$_{DD}$ = 2.7 to 6.0 V)

Parameter	Symbol	Test Conditions	MIN.	MAX.	Unit
ASTB high-level width	t_{ASTH}		t_{CY} − 80		ns
Address setup time	t_{ADS}		t_{CY} − 80		ns
Address hold time	t_{ADH}		$0.4t_{CY}$ − 10		ns
Data input time from address	t_{ADD1}			$(3+2n)t_{CY}$−160	ns
	t_{ADD2}			$(4+2n)t_{CY}$−200	ns
Data input time from $\overline{RD}$↓	t_{RDD1}			$(1.4+2n)t_{CY}$−70	ns
	t_{RDD2}			$(2.4+2n)t_{CY}$−70	ns
Read data hold time	t_{RDH}		0		ns
$\overline{RD}$ low-level width	t_{RDL1}		$(1.4+2n)t_{CY}$−20		ns
	t_{RDL2}		$(2.4+2n)t_{CY}$−20		ns
$\overline{WAIT}$↓ input time from $\overline{RD}$↓	t_{RDWT1}			t_{CY}−100	ns
	t_{RDWT2}			$2t_{CY}$−100	ns
$\overline{WAIT}$↓ input time from $\overline{WR}$↓	t_{WRWT}			$2t_{CY}$−100	ns
$\overline{WAIT}$ low-level width	t_{WTL}		$(1+2n)t_{CY}$	$(2+2n)t_{CY}$	ns
Write data setup time	t_{WDS}		$(2.4+2n)t_{CY}$−60		ns
Write data hold time	t_{WDH}		20		ns
$\overline{WR}$ low-level width	t_{WRL}		$(2.4+2n)t_{CY}$−20		ns
$\overline{RD}$↓ delay time from ASTB↓	t_{ASTRD}		$0.4t_{CY}$ −30		ns
$\overline{WR}$↓ delay time from ASTB↓	t_{ASTWR}		$1.4t_{CY}$ −30		ns
ASTB↑ delay time from $\overline{RD}$↑ in external fetch	t_{RDAST}		t_{CY} −10	t_{CY} + 20	ns
Address hold time from $\overline{RD}$↑ in external fetch	t_{RDADH}		t_{CY} − 50	t_{CY} + 50	ns
Write data output time from $\overline{RD}$↑	t_{RDWD}		$0.4t_{CY}$ − 20		ns
Write data output time from $\overline{WR}$↓	t_{WRWD}		0	60	ns
Address hold time from $\overline{WR}$↑	t_{WRADH}		t_{CY}	t_{CY} + 60	ns
$\overline{RD}$↑ delay time from $\overline{WAIT}$↑	t_{WTRD}		$0.6t_{CY}$ + 180	$2.6t_{CY}$ + 180	ns
$\overline{WR}$↑ delay time from $\overline{WAIT}$↑	t_{WTWR}		$0.6t_{CY}$ + 120	$2.6t_{CY}$+ 120	ns

Remarks 1. MCS: Oscillation mode selection register (OSMS) bit 0

2. PCC2 to PCC0: Processor clock control register (PCC) bit 2 to bit 0

3. t_{CY} = T_{CY}/4

4. n indicates the number of waits.

(3) Serial Interface (T$_A$ = –40 to +85°C, V$_{DD}$ = 2.7 to 6.0 V)

(a) Serial interface channel 0

(i) 3-wire serial I/O mode ($\overline{SCK0}$... Internal clock output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
$\overline{SCK0}$ cycle time	t$_{KCY1}$	V$_{DD}$ = 4.5 to 6.0 V	800			ns
			1600			ns
$\overline{SCK0}$ high-/low-level width	t$_{KH1}$, t$_{KL1}$	V$_{DD}$ = 4.5 to 6.0 V	t$_{KCY1}$/2–50			ns
			t$_{KCY1}$/2–100			ns
SI0 setup time (to $\overline{SCK0}\uparrow$)	t$_{SIK1}$	V$_{DD}$ = 4.5 to 6.0 V	100			ns
			150			ns
SI0 hold time (to $\overline{SCK0}\uparrow$)	t$_{KSI1}$		400			ns
SO0 output delay time from $\overline{SCK0}\downarrow$	t$_{KSO1}$	C = 100 pF **Note**			300	ns

Note C is the load capacitance of the $\overline{SCK0}$ and SO0 output lines.

(ii) 3-wire serial I/O mode ($\overline{SCK0}$... External clock input)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
$\overline{SCK0}$ cycle time	t$_{KCY2}$	V$_{DD}$ = 4.5 to 6.0 V	800			ns
			1600			ns
$\overline{SCK0}$ high-/low-level width	t$_{KH2}$, t$_{KL2}$	V$_{DD}$ = 4.5 to 6.0 V	400			ns
			800			ns
SI0 setup time (to $\overline{SCK0}\uparrow$)	t$_{SIK2}$		100			ns
SI0 hold time (to $\overline{SCK0}\uparrow$)	t$_{KSI2}$		400			ns
SO0 output delay time from $\overline{SCK0}\downarrow$	t$_{KSO2}$	C = 100 pF **Note**			300	ns
$\overline{SCK0}$ rise, fall time	t$_{R2}$, t$_{F2}$	When using external device expansion function			160	ns
		When not using external device expansion function			1000	ns

Note C is the load capacitance of the SO0 output line.

(iii) 2-wire serial I/O mode ($\overline{\text{SCK0}}$... Internal clock output)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
$\overline{\text{SCK0}}$ cycle time	t_{KCY3}	R = 1 kΩ, C = 100 pF **Note**		1600			ns
$\overline{\text{SCK0}}$ high-level width	t_{KH3}			$t_{KCY3}/2-160$			ns
$\overline{\text{SCK0}}$ low-level width	t_{KL3}		V_{DD} = 4.5 to 6.0 V	$t_{KCY3}/2-50$			ns
				$t_{KCY3}/2-100$			ns
SB0, SB1 setup time (to $\overline{\text{SCK0}}$↑)	t_{SIK3}		V_{DD} = 4.5 to 6.0 V	300			ns
				350			ns
SB0, SB1 hold time (to $\overline{\text{SCK0}}$↑)	t_{KSI3}			600			ns
SB0, SB1 output delay time from $\overline{\text{SCK0}}$↓	t_{KSO3}			0		300	ns

Note   R and C are the load resistance and load capacitance of the $\overline{\text{SCK0}}$, SB0, and SB1 output lines.

(iv) 2-wire serial I/O mode ($\overline{\text{SCK0}}$... External clock input)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
$\overline{\text{SCK0}}$ cycle time	t_{KCY4}			1600			ns
$\overline{\text{SCK0}}$ high-level width	t_{KH4}			650			ns
$\overline{\text{SCK0}}$ low-level width	t_{KL4}			800			ns
SB0, SB1 setup time (to $\overline{\text{SCK0}}$↑)	t_{SIK4}			100			ns
SB0, SB1 hold time (to $\overline{\text{SCK0}}$↑)	t_{KSI4}			$t_{KCY4}/2$			ns
SB0, SB1 output delay time from $\overline{\text{SCK0}}$↓	t_{KSO4}	R = 1 kΩ, C = 100 pF **Note**	V_{DD} = 4.5 to 6.0 V	0		300	ns
				0		500	ns
$\overline{\text{SCK0}}$ rise, fall time	t_{R4}, t_{F4}	When using external device expansion function				160	ns
		When not using external device expansion function				1000	ns

Note   R and C are the load resistance and load capacitance of the SB0 and SB1 output lines.

(v) I²C bus mode (SCL... Internal clock output)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
SCL cycle time	t_{KCY5}	R = 1 kΩ,	V_{DD} = 2.7 to 6.0 V	10			μs
		C = 100 pF [Note]		20			μs
SCL high-level width	t_{KH5}		V_{DD} = 2.7 to 6.0 V	t_{KCY5}—160			ns
				t_{KCY5}—190			ns
SCL low-level width	t_{KL5}		V_{DD} = 4.5 to 6.0 V	t_{KCY5}—50			ns
				t_{KCY5}—100			ns
SDA0, SDA1 setup time (to SCL↑)	t_{SIK5}		V_{DD} = 2.7 to 6.0 V	200			ns
				300			ns
SDA0, SDA1 hold time (to SCL↓)	t_{KSI5}			0			ns
SDA0, SDA1 output delay time from SCL↓	t_{KSO5}		V_{DD} = 4.5 to 6.0 V	0		300	ns
				0		500	ns
SCL↑ → SDA0, SDA1↓ or SCL↑ → SDA0, SDA1↑	t_{KSB}			200			ns
SDA0, SDA1↓ → SCL↓	t_{SBK}			400			ns
SDA0, SDA1 high-level width	t_{SBH}			500			ns

Note R and C are the load resistance and load capacitance of the SCL, SDA0, and SDA1 output lines.

(vi) I²C bus mode (SCL... External clock input)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
SCL cycle time	t_{KCY6}			1000			ns
SCL high-/low-level width	t_{KH6}, t_{KL6}			400			ns
SDA0, SDA1 setup time (to SCL↑)	t_{SIK6}			200			ns
SDA0, SDA1 hold time (to SCL↓)	t_{KSI6}			0			ns
SDA0, SDA1 output delay time from SCL↓	t_{KSO6}	R = 1 kΩ	V_{DD} = 4.5 to 6.0 V	0		300	ns
		C = 100 pF [Note]		0		500	ns
SCL↑ → SDA0, SDA1↓ or SCL↑ → SDA0, SDA1↑	t_{KSB}			200			ns
SDA0, SDA1↓ → SCL↓	t_{SBK}			400			ns
SDA0, SDA1 high-level width	t_{SBH}			500			ns
SCL rise, fall time	t_{R6},	When using external device expansion function				160	ns
	t_{F6}	When not using external device expansion function				1000	ns

Note R and C are the load resistance and load capacitance of the SDA0 and SDA1 output lines.

Phase-out/Discontinued

(b) Serial interface channel 1

(i) 3-wire serial I/O mode (SCK1...Internal clock output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
SCK1 cycle time	t_{KCY7}	V_{DD} = 4.5 to 6.0 V	800			ns
			1600			ns
SCK1 high-/low-level width	t_{KH7}	V_{DD} = 4.5 to 6.0 V	$t_{KCY7}/2-50$			ns
	t_{KL7}		$t_{KCY7}/2-100$			ns
SI1 setup time (to SCK1↑)	t_{SIK7}	V_{DD} = 4.5 to 6.0 V	100			ns
			150			ns
SI1 hold time (to SCK1↑)	t_{KSI7}		400			ns
SO1 output delay time from SCK1↓	t_{KSO7}	C = 100 pF **Note**			300	ns

Note C is the load capacitance of the SCK1 and SO1 output lines.

(ii) 3-wire serial I/O mode (SCK1...External clock input)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
SCK1 cycle time	t_{KCY8}	V_{DD} = 4.5 to 6.0 V	800			ns
			1600			ns
SCK1 high-/low-level width	t_{KH8}	V_{DD} = 4.5 to 6.0 V	400			ns
	t_{KL8}		800			ns
SI1 setup time (to SCK1↑)	t_{SIK8}		100			ns
SI1 hold time (to SCK1↑)	t_{KSI8}		400			ns
SO1 output delay time from SCK1↓	t_{KSO8}	C = 100 pF **Note**			300	ns
SCK1 rise, fall time	t_{R8}, t_{F8}	When using external device expansion function			160	ns
		When not using external device expansion function			1000	ns

Note C is the load capacitance of the SO1 output line.

Phase-out/Discontinued

(iii) 3-wire serial I/O mode with automatic transmit/receive function ($\overline{\text{SCK1}}$... Internal clock output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
$\overline{\text{SCK1}}$ cycle time	t_{KCY9}	V_{DD} = 4.5 to 6.0 V	800			ns
			1600			ns
$\overline{\text{SCK1}}$ high-/low-level width	t_{KH9}	V_{DD} = 4.5 to 6.0 V	$t_{KCY9}/2-50$			ns
	t_{KL9}		$t_{KCY9}/2-100$			ns
SI1 setup time (to $\overline{\text{SCK1}}\uparrow$)	t_{SIK9}	V_{DD} = 4.5 to 6.0 V	100			ns
			150			ns
SI1 hold time (to $\overline{\text{SCK1}}\uparrow$)	t_{KSI9}		400			ns
SO1 output delay time from $\overline{\text{SCK1}}\downarrow$	t_{KSO9}	C = 100 pF **Note**			300	ns
STB$\uparrow$ from $\overline{\text{SCK1}}\uparrow$	t_{SBD}		$t_{KCY9}/2-100$		$t_{KCY9}/2+100$	ns
Strobe signal high-level width	t_{SBW}		$t_{KCY9}-30$		$t_{KCY9}+30$	ns
Busy signal setup time (to busy signal detection timing)	t_{BYS}		100			ns
Busy signal hold time (to busy signal detection timing)	t_{BYH}	V_{DD} = 4.5 to 6.0 V	100			ns
			150			ns
$\overline{\text{SCK1}}\downarrow$ from busy inactive	t_{SPS}				$2t_{KCY9}$	ns

Note C is the load capacitance of the $\overline{\text{SCK1}}$ and SO1 output lines.

(iv) 3-wire serial I/O mode with automatic transmit/receive function ($\overline{\text{SCK1}}$... External clock input)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
$\overline{\text{SCK1}}$ cycle time	t_{KCY10}	V_{DD} = 4.5 to 6.0 V	800			ns
			1600			ns
$\overline{\text{SCK1}}$ high-/low-level width	t_{KH10}, t_{KL10}	V_{DD} = 4.5 to 6.0 V	400			ns
			800			ns
SI1 setup time (to $\overline{\text{SCK1}}\uparrow$)	t_{SIK10}		100			ns
SI1 hold time (from $\overline{\text{SCK1}}\uparrow$)	t_{KSI10}		400			ns
SO1 output delay time from $\overline{\text{SCK1}}\downarrow$	t_{KSO10}	C = 100 pF **Note**			300	ns
$\overline{\text{SCK1}}$ rise, fall time	t_{R10}, t_{F10}	When using external device expansion function			160	ns
		When not using external device expansion function			1000	ns

Note C is the load capacitance of the SO1 output line.

(c) Serial interface channel 2

   (i) 3-wire serial I/O mode ($\overline{\text{SCK2}}$...Internal clock output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
$\overline{\text{SCK2}}$ cycle time	t_{KCY11}	V_{DD} = 4.5 to 6.0 V	800			ns
			1600			ns
$\overline{\text{SCK2}}$ high-/low-level width	t_{KH11}, t_{KL11}	V_{DD} = 4.5 to 6.0 V	$t_{KCY11}/2-50$			ns
			$t_{KCY11}/2-100$			ns
SI2 setup time (to $\overline{\text{SCK2}}\uparrow$)	t_{SIK11}	V_{DD} = 4.5 to 6.0 V	100			ns
			150			ns
SI2 hold time (to $\overline{\text{SCK2}}\uparrow$)	t_{KSI11}		400			ns
SO2 output delay time from $\overline{\text{SCK2}}\downarrow$	t_{KSO11}	C = 100 pF **Note**			300	ns

Note   C is the load capacitance of the $\overline{\text{SCK2}}$ and SO2 output lines.

   (ii) UART mode (Dedicated baud rate generator output)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		V_{DD} = 4.5 to 6.0 V			78125	bps
					39063	bps

AC Timing Test Point (Excluding X1, XT1 Input)
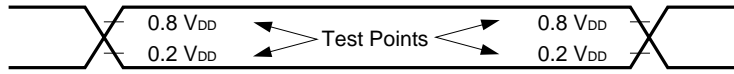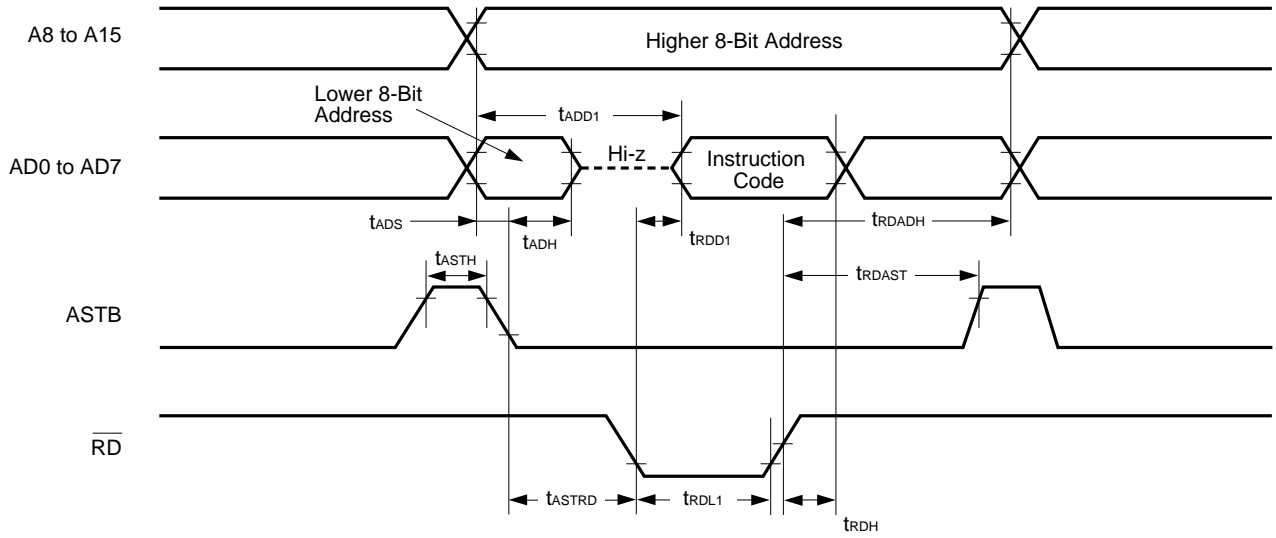

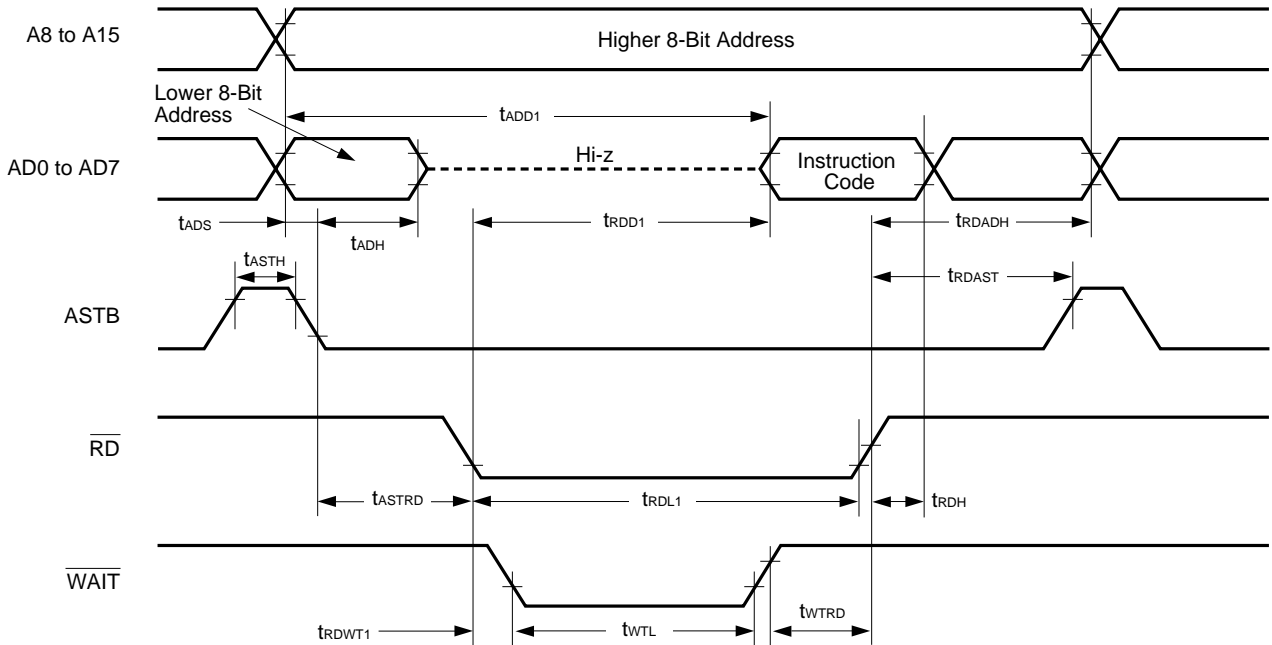**Clock Timing**
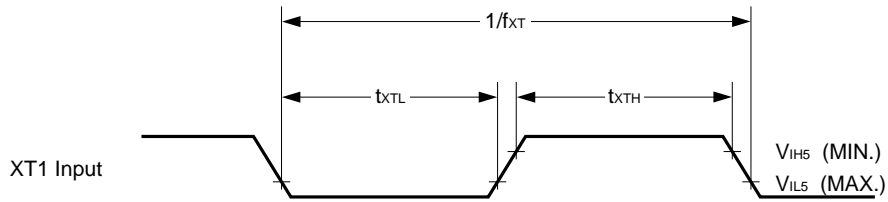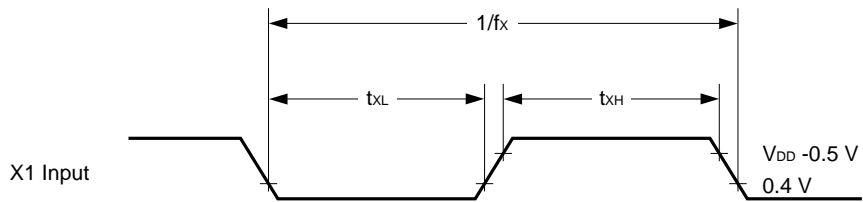
TI Timing
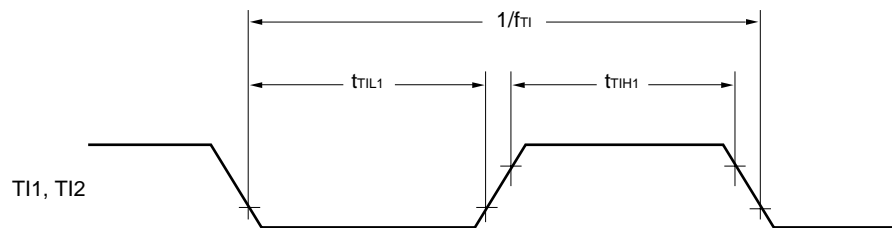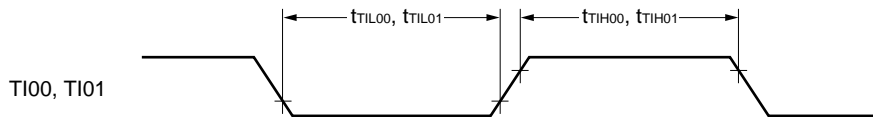
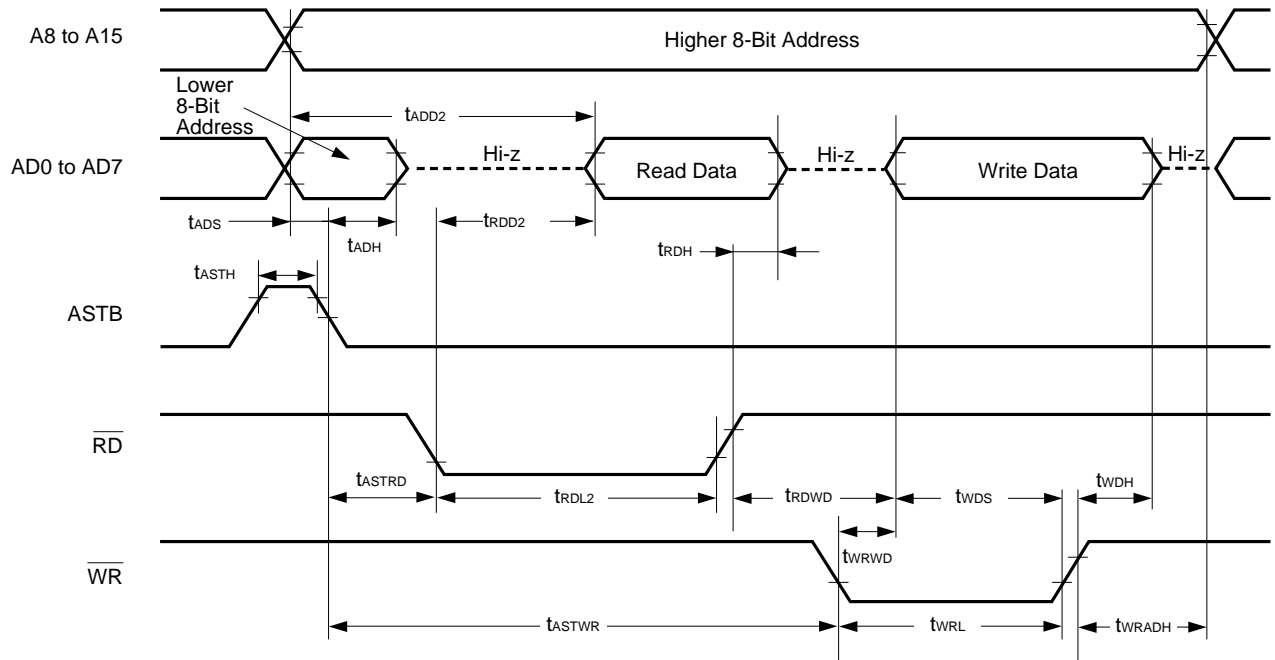**Read/Write Operation**

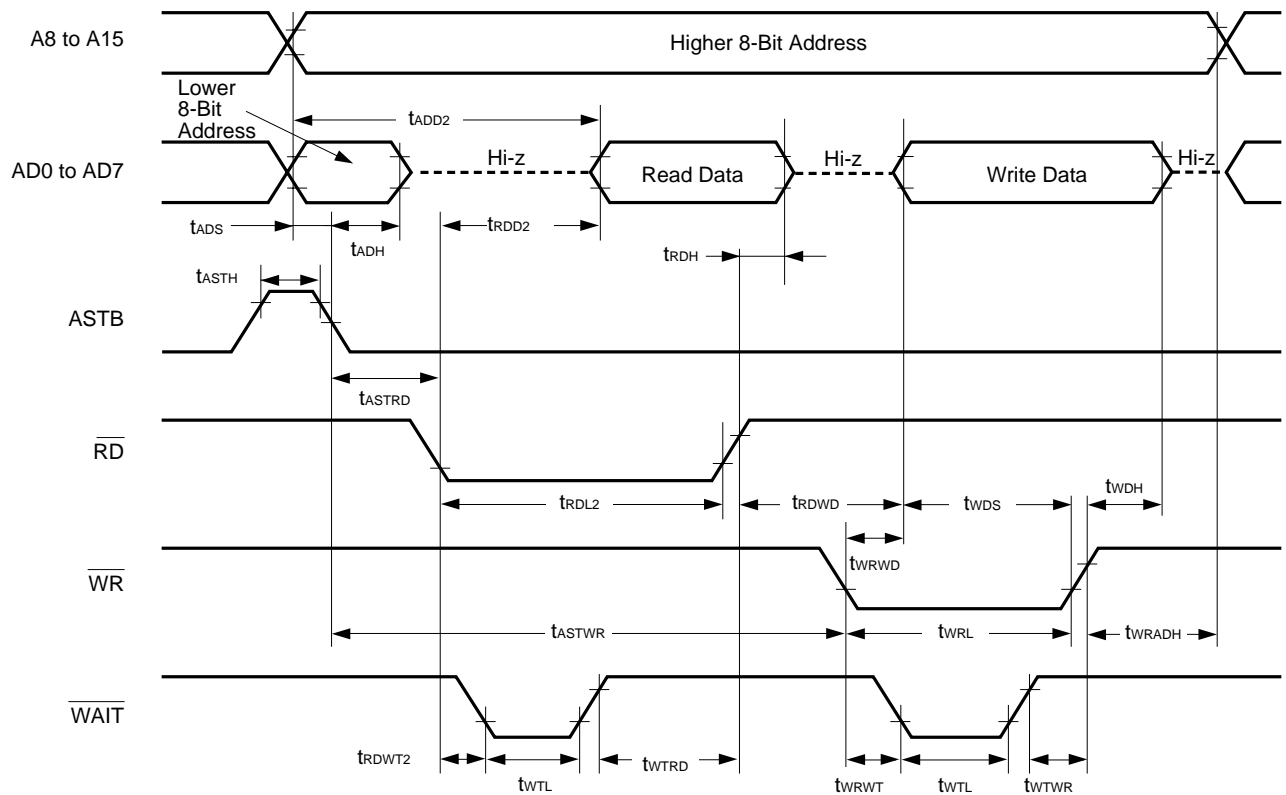**External Fetch (No Wait) :**

External Fetch (Wait Insertion) :
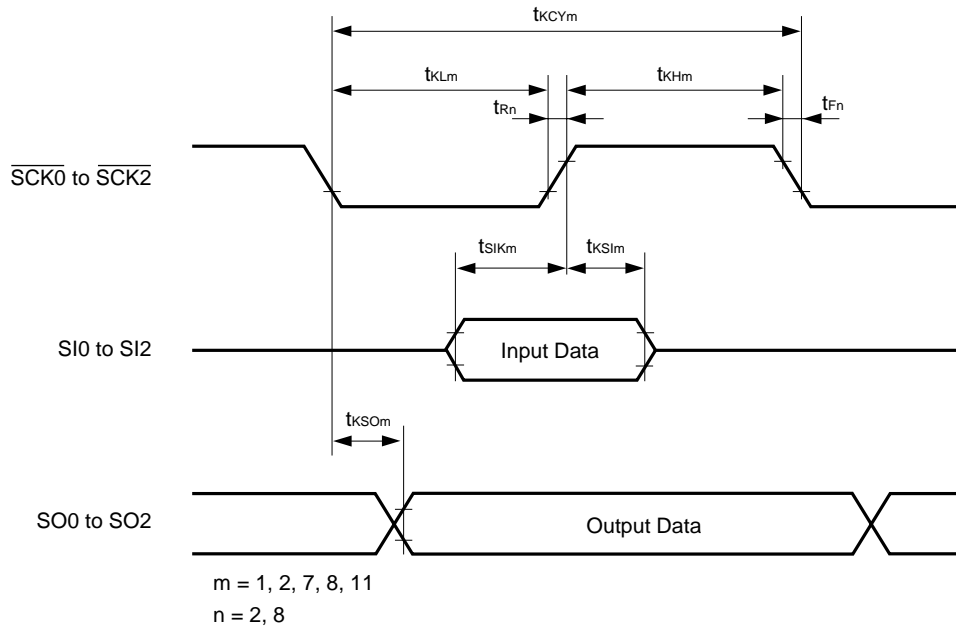
External Data Access (No Wait) :
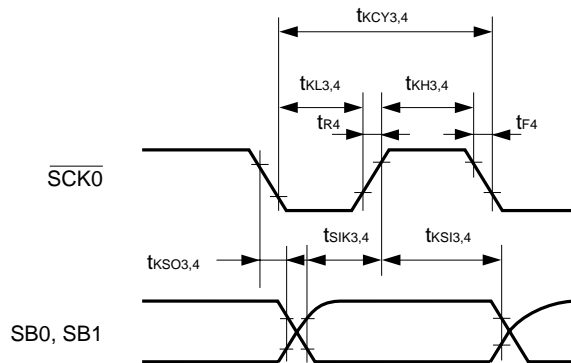

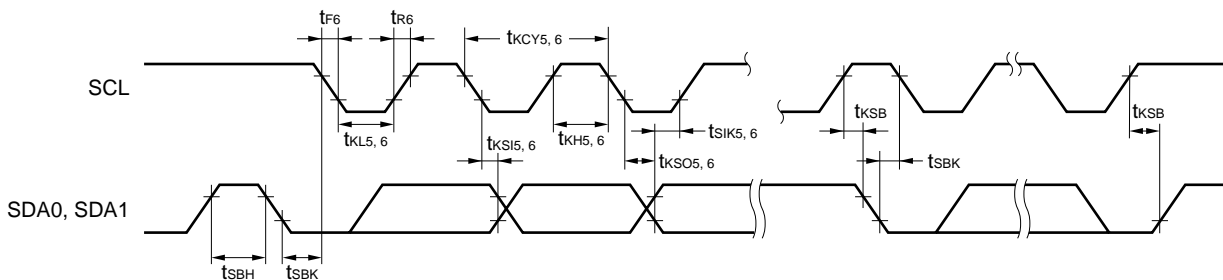**External Data Access (Wait Insertion) :**

Serial Transfer Timing

3-wire Serial I/O Mode :
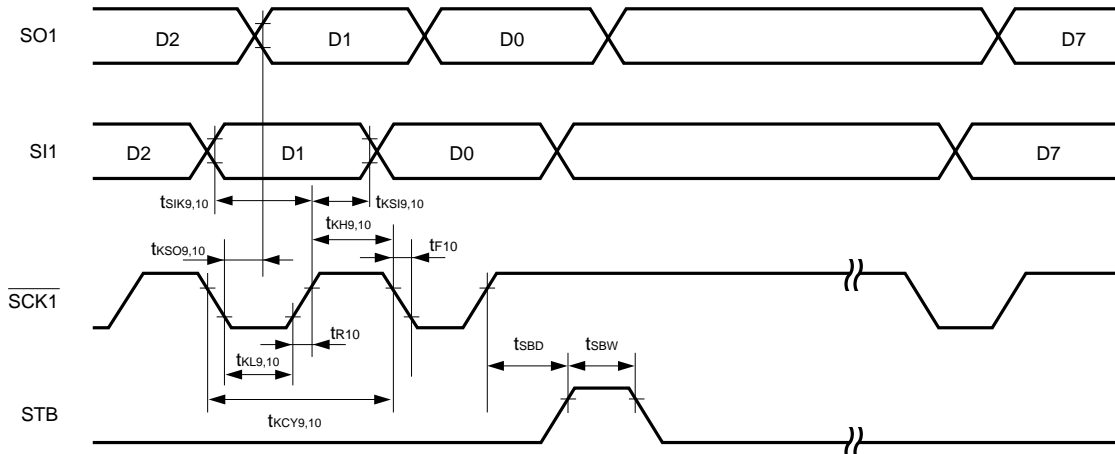

m = 1, 2, 7, 8, 11
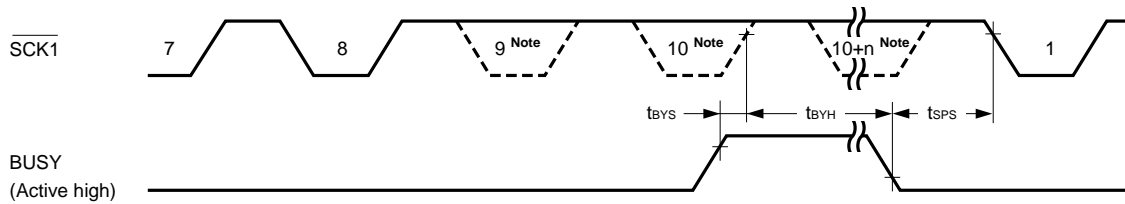n = 2, 8

2-wire Serial I/O Mode :

I²C Bus Mode

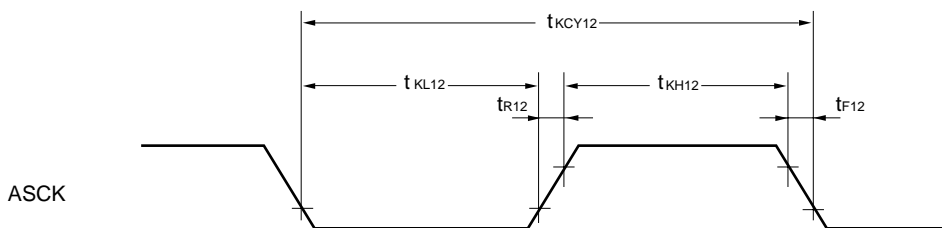**3-wire Serial I/O Mode with Automatic Transmit/Receive Function :**

3-wire Serial I/O Mode with Automatic Transmit/Receive Function (Busy Processing) :

Note The signal is not actually driven low here; it is shown as such to indicate the timing.

UART Mode (External Clock Input) :

A/D CONVERTER CHARACTERISTICS (T_A = –40 to +85°C, AV_{DD} = V_{DD} = 2.7 to 6.0 V, AV_{SS} = V_{SS} = 0 V)

Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Resolution			8	8	8	bit
Overall error **Note**		2.7 V $\leq$ AV_{REF0} $\leq$ AV_{DD}			0.6	%
Conversion time	t_{CONV}		19.1		200	μs
Sampling time	t_{SAMP}		12/f_{XX}			μs
Analog input voltage	V_{IAN}		AV_{SS}		AV_{REF0}	V
Reference voltage	AV_{REF0}		2.7		AV_{DD}	V
Resistance between AV_{REF0} and AV_{SS}	R_{AIREF0}		4	14		kΩ

Note Overroll error excluding quantization error ($\pm$1/2 LSB). It is indicated as a ratio to the full-scale value.

Caution **For pins which also function as port pins, do not perform the following operations during A/D conversion. If these operations are performed, the total error ratings cannot be kept (except for LCD segment output alternate-function pin).**
(1) Rewrite the output latch while the pin is used as a port pin.
(2) Change the output level of the pin used as an output pin, even if it is not used as a port pin.

Remarks 1. f_{XX}: Main system clock frequency (f_X or f_X/2)
2. f_X: Main system clock oscillation frequency

D/A CONVERTER CHARACTERISTICS (T_A = –40 to +85°C, V_{DD} = 2.7 to 6.0 V, AV_{SS} = V_{SS} = 0 V)

Parameter	Symbol	Test Conditions		MIN.	TYP.	MAX.	Unit
Resolution						8	bit
Overall error		R = 2MΩ **Note 1**				1.2	%
		R = 4MΩ **Note 1**				0.8	%
		R = 10MΩ **Note 1**				0.6	%
Settling time		**Note 1** C=30pF	4.5 V $\leq$ AV_{REF1} $\leq$ 6.0 V			10	μs
			2.7 V $\leq$ AV_{REF1} < 4.5 V			15	μs
Output resistance	R_O	**Note 2**			10		kΩ
Analog reference voltage	AV_{REF1}			2.0		V_{DD}	V
Resistance between AV_{REF1} and AV_{SS}	R_{AIREF1}	DACS0, DACS1 = 55H **Note 2**		4	8		kΩ

Notes 1. R and C are the load resistance and load capacitance of the D/A converter output pins.
2. Value for D/A converter 1 channel

**Remark** DACS0, DACS1: D/A conversion value setting register 0, 1

Data Memory STOP Mode Low Supply Voltage Data Retention Characteristics (T$_A$ = −40 to + 85°C)

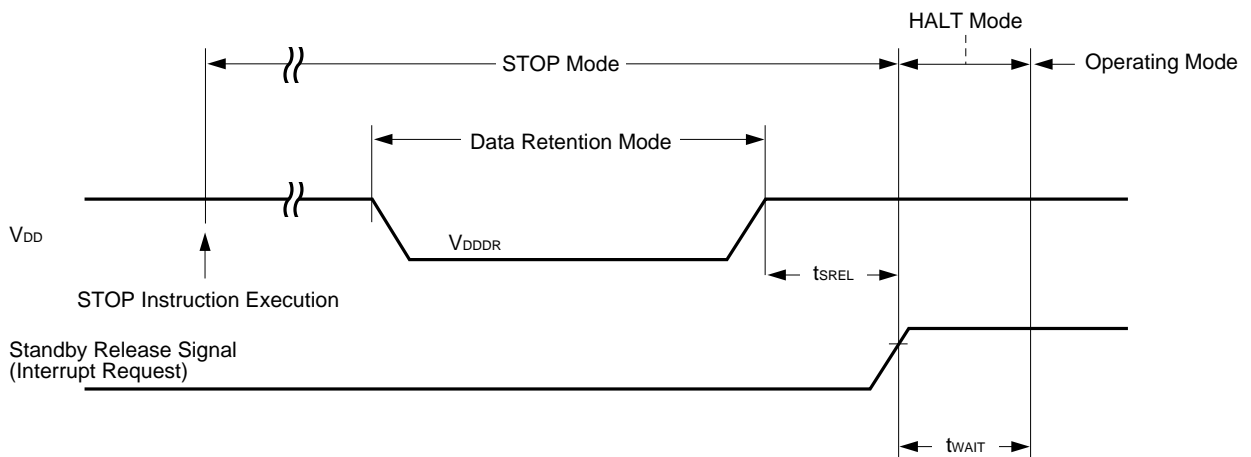| Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
Data retention power supply voltage	V$_{DDDR}$		1.8		6.0	V
Data retention power supply current	I$_{DDDR}$	V$_{DDDR}$ = 1.8 V Subsystem clock stop and feed-back resistor disconnected		0.1	10	μA
Release signal set time	t$_{SREL}$		0			μs
Oscillation stabiliza-tion wait time	t$_{WAIT}$	Release by $\overline{\text{RESET}}$		2^{17}/fx		ms
		Release by interrupt request		**Note**		ms

Note In combination with bits 0 to 2 (OSTS0 to OSTS2) of the oscillation stabilization time select register, selection of 2^{12}/fxx and 2^{14}/fxx to 2^{17}/fxx is possible.

Remark fxx: Main system clock frequency (fx or fx/2)
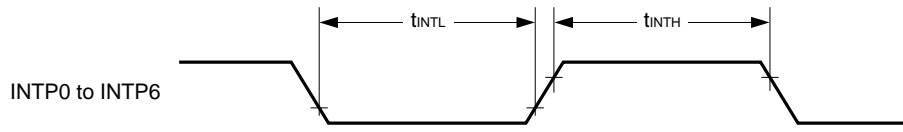
fx: Main system clock oscillation frequency

Data Retention Timing (STOP Mode Release by $\overline{\text{RESET}}$)
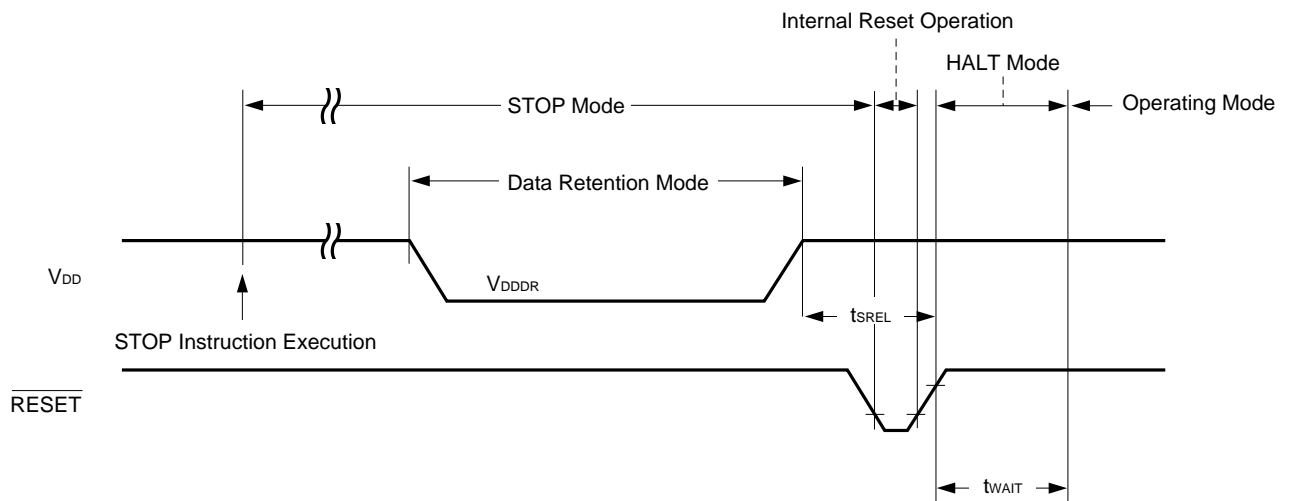
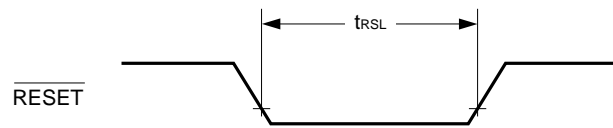**Data Retention Timing (Standby Release Signal: STOP Mode Release by Interrupt Request Signal)**

Interrupt Request Input Timing

INTP0 to INTP6

t_{INTL} t_{INTH}

RESET Input Timing

$\overline{RESET}$

t_{RSL}

44444

μPD78056FYGC-×××-8BT, 78058FYGC-×××-8BT

80 PIN PLASTIC QFP (14×14)

detail of lead end
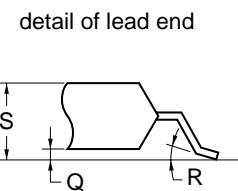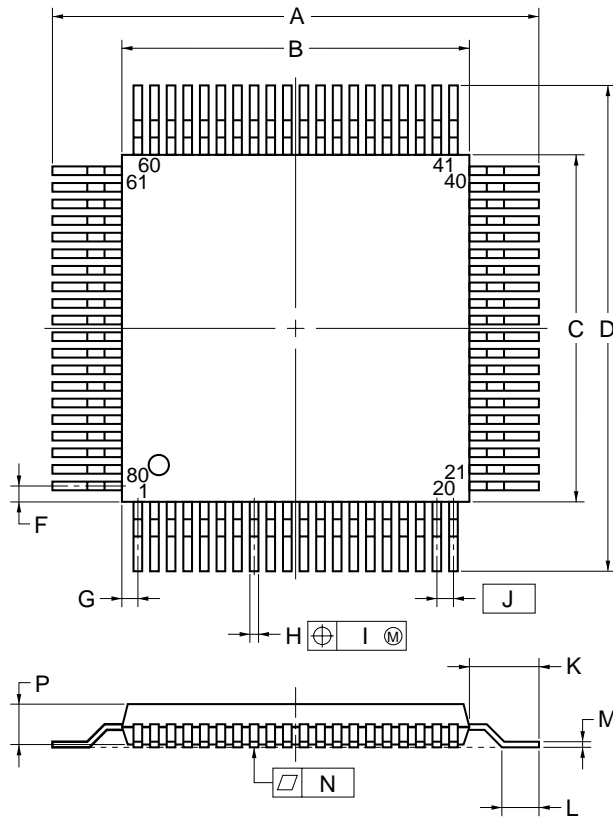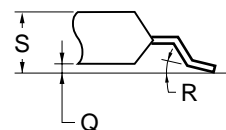
NOTE

Each lead centerline is located within 0.13 mm (0.005 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
A	17.20±0.20	0.677±0.008
B	14.00±0.20	$0.551^{+0.009}_{-0.008}$
C	14.00±0.20	$0.551^{+0.009}_{-0.008}$
D	17.20±0.20	0.677±0.008
F	0.825	0.032
G	0.825	0.032
H	0.32±0.06	$0.013^{+0.002}_{-0.003}$
I	0.13	0.005
J	0.65 (T.P.)	0.026 (T.P.)
K	1.60±0.20	0.063±0.008
L	0.80±0.20	$0.031^{+0.009}_{-0.008}$
M	$0.17^{+0.03}_{-0.07}$	$0.007^{+0.001}_{-0.003}$
N	0.10	0.004
P	1.40±0.10	0.055±0.004
Q	0.125±0.075	0.005±0.003
R	$3°^{+7°}_{-3°}$	$3°^{+7°}_{-3°}$
S	1.70 MAX.	0.067 MAX.

P80GC-65-8BT

80 PIN PLASTIC TQFP (FINE PITCH) (12 × 12)

detail of lead end

NOTE

Each lead centerline is located within 0.10 mm (0.004 inch) of its true position (T.P.) at maximum material condition.

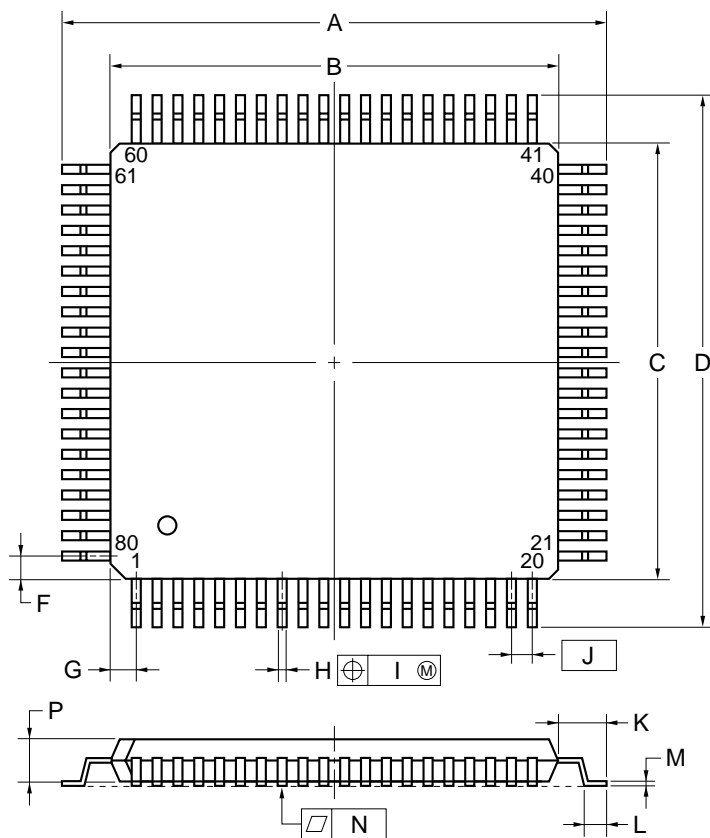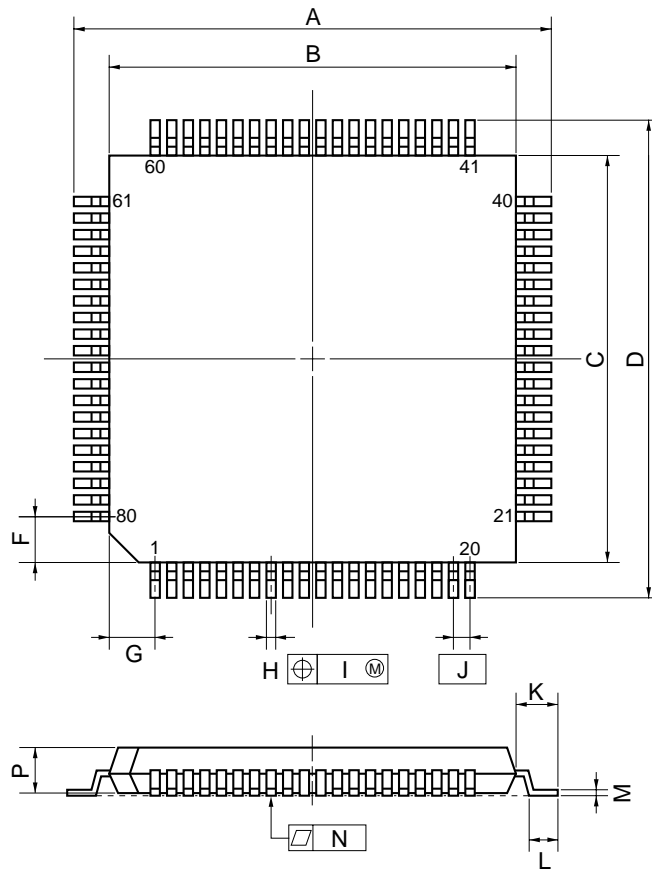| ITEM	MILLIMETERS	INCHES
A	14.0±0.2	$0.551^{+0.009}_{-0.008}$
B	12.0±0.2	$0.472^{+0.009}_{-0.008}$
C	12.0±0.2	$0.472^{+0.009}_{-0.008}$
D	14.0±0.2	$0.551^{+0.009}_{-0.008}$
F	1.25	0.049
G	1.25	0.049
H	$0.22^{+0.05}_{-0.04}$	0.009±0.002
I	0.10	0.004
J	0.5 (T.P.)	0.020 (T.P.)
K	1.0±0.2	$0.039^{+0.009}_{-0.008}$
L	0.5±0.2	$0.020^{+0.008}_{-0.009}$
M	$0.145^{+0.055}_{-0.045}$	0.006±0.002
N	0.10	0.004
P	1.05	0.041
Q	0.05±0.05	0.002±0.002
R	5°±5°	5°±5°
S	1.27 MAX.	0.050 MAX.

P80GK-50-BE9-4

Remark Dimensions and materials of ES product are the same as those of mass-production products.

13. RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the conditions recommended in the table below.

For detail of recommended soldering conditions, refer to the information document **Semiconductor Device Mounting Technology Manual (C10535E).**

For soldering methods and conditions other than those recommended below, contact an NEC sales representative.

Table 13-1. Surface Mounting Type Soldering Conditions (1/2)

(1) μPD78056FYGC-×××-3B9 :   80-pin plastic QFP (14 × 14 mm, resin thickness 2.7 mm)
μPD78058FYGC-×××-3B9 :   80-pin plastic QFP (14 × 14 mm, resin thickness 2.7 mm)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Duration: 30 sec. max. (at 210°C or above), Number of times: Three times max.	IR35-00-3
VPS	Package peak temperature: 215°C, Duration: 40 sec. max. (at 200°C or above), Number of times: Three times max.	VP15-00-3
Wave soldering	Solder bath temperature : 260°C max., Duration : 10 sec. max., Number of times: once, Preheating temperature : 120°C max. (package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C max. Duration: 3 sec. max. (per pin row)	—

Caution   Use of more than one soldering method should be avoided (except in the case of partial heating).

★ **(2) μPD78056FYGC-×××-8BT :   80-pin plastic QFP (14 × 14 mm, resin thickness 1.4 mm)**
μPD78058FYGC-×××-8BT :   80-pin plastic QFP (14 × 14 mm, resin thickness 1.4 mm)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Duration: 30 sec. max. (at 210°C or above), Number of times: Twice max.	IR35-00-2
VPS	Package peak temperature: 215°C, Duration: 40 sec. max. (at 200°C or above), Number of times: Twice max.	VP15-00-2
Wave soldering	Solder bath temperature : 260°C max., Duration : 10 sec. max., Number of times: once, Preheating temperature : 120°C max. (package surface temperature)	WS60-00-1
Partial heating	Pin temperature: 300°C max. Duration: 3 sec. max. (per pin row)	—

Caution   Use of more than one soldering method should be avoided (except in the case of partial heating).

Phase-out/Discontinued

Table 13-1. Surface Mounting Type Soldering Conditions (2/2)

(3) μPD78058FYGK-$\times\times\times$-BE9:   80-pin plastic QFP (fine pitch) (12 $\times$ 12 mm)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Package peak temperature: 235°C, Duration: 30 sec. max. (at 210°C or above), Number of times: Three times max., Time limit: 7 days **Note** (thereafter 10 hours 125°C prebaking required)	IR35-107-3
VPS	Package peak temperature: 215°C, Duration: 40 sec. max. (at 200°C or above), Number of times: Three times max., Time limit: 7 days **Note** (thereafter 10 hours 125°C prebaking required)	VP15-107-3
Wave Soldering	Solder bath temperature: 260°C max., Duration:10 sec. max., Number of times: once, Preheating temperature: 120°C max. (package surface tempeature). Time limit: 7 days**Note** (therefore 10 hours 125°C prebaking required)	WS60-107-1
Partial Heating	Pin temperature: 300°C max. Duration: 3 sec. max. (per pin row)	—

Note   For the storage period after dry-pack decompression storage conditions are max. 25°C, 65 % RH.

Caution   Use of more than one soldering method should be avoided (except in the case of partial heating).

APPENDIX A. DEVELOPMENT TOOLS

The following development tools are available for system development using the μPD78058FY Subseries.

Language Processing Software

RA78K/0 **Notes 1, 2, 3, 4**	Assembler package common to 78K/0 Series
CC78K/0 **Notes 1, 2, 3, 4**	C compiler package common to 78K/0 Series
DF78054 **Notes 1, 2, 3, 4**	Device file common to μPD78054 Subseries
CC78K/0-L **Notes 1, 2, 3, 4**	C compiler library source file common to 78K/0 Series

PROM Writing Tools

PG-1500	PROM programmer
PA-78P054GC	Programmer adapters connected to PG-1500
PG-1500 controller **Notes 1, 2**	PG-1500 control program

Debugging Tools

IE-78000-R	In-circuit emulator common to 78K/0 Series
IE-78000-R-A	78K/0 Series common to in-circuit emulator (for integrated debugger)
IE-78000-R-BK	Break board common to 78K/0 Series
IE-78064-R-EM **Note 8**	Emulation board common to μPD78064 Subseries
IE-780308-R-EM	Emulation board common to μPD780308 Subseries
★ IE-78000-R-SV3	Interface adapter and cable when EWS is used as host machine (for IE-78000-R-A)
★ IE-70000-98-IF-B	Interface adapter when PC-9800 series (except notebook type) is used as host machine.
★ IE-70000-98N-IF	Interface adapter and cable when notebook type PC-9800 series is used as host machine.
★ IE-70000-PC-IF-B	Interface adapter when IBM PC/AT™ and compatibles are used as host machine.
EP-78230GC-R	Emulation probe common to μPD78234 Subseries
EP-78054GK-R	Emulation probe common to μPD78054 Subseries
EV-9200GC-80	Socket to be mounted on the target system board manufactured for 80-pin plastic QFP (GC-3B9, GC-8BT type)
TGK-080SDW	Adapter to be mounted in the target system board manufactured for 80-pin plastic TQFP (GK-BE9 type) **Product made by TOKYO ELETECH Corporation ((03) 5295-1661). Contact an NEC dealer regarding the purchase of this product.**
SM78K0 **Notes 5, 6, 7**	System simulator common to 78K/0 Series
ID78K0 **Notes 4, 5, 6, 7**	Integrated debugger for IE-78000-R
SD78K/0 **Notes 1, 2**	IE-78000-R screen debugger
DF78054 **Notes 1, 2, 4, 5, 6, 7**	μPD78054 Subseries device file

APPENDIX B. RELATED DOCUMENTS

Device Related Documents

Document Name	Document No. (English)	Document No. (Japanese)
μPD78058F, 78058FY Subseries User's Manual	U12068E	U12068J
μPD78056FY, 78058FY Data Sheet	This document	U10121J
μPD78P058FY Data Sheet	U12076E	U12076J
78K/0 Series User's Manual-Instruction	U12326E	U12326J
78K/0 Series Instruction Set	–	U10904J
78K/0 Series Instruction Table	–	U10903J

Caution   **The above related documents are subject to change without notice. Be sure to read the latest documents before designing.**

Development Tool Related Documents (User's Manual)

Document Name		Document No. (English)	Document No. (Japanese)
RA78K Series Assembler Package	Operation	EEU-1399	EEU-809
	Language	EEU-1404	EEU-815
RA78K Series Structured Assembler Preprocessor		EEU-1402	U12323J
RA78K0 Assembler Package	Operation	U11802E	U11802J
	Assembly Language	U11801E	U11801J
	Structured Assembly Language	U11789E	U11789J
CC78K Series C Compiler	Operation	EEU-1280	EEU-656
	Language	EEU-1284	EEU-655
CC78K0 C Compiler	Operation	U11517E	U11517J
	Language	U11518E	U11518J
CC78K/0 C Compiler Application Note	Programming know-how	EEA-1208	EEA-618
CC78K Series Library Source File		–	U12322J
PG-1500 PROM Programmer		EEU-1335	U11940J
PG-1500 Controller PC-9800 Series (MS-DOS) based		EEU-1291	EEU-704
PG-1500 Controller IBM PC Series (PC DOS) based		U10540E	EEU-5008
IE-78000-R		U11376E	U11376J
IE-78000-R-A		U10057E	U10057J
IE-78000-R-BK		EEU-1427	EEU-867
IE-78064-R-EM		EEU-1443	EEU-905
IE-780308-R-EM		U11362E	U11362J
EP-78230		EEU-1515	EEU-985
EP-78054GK-R		EEU-1468	EEU-932
SM78K0 System Simulator, Windows based	Reference	U10181E	U10181J
SM78K Series System Simulator	External parts user open interface specification	U10092E	U10092J
ID78K0 Integrated Debugger, EWS based	Reference	–	U11151J
ID78K0 Integrated Debugger, PC based	Reference	U11539E	U11539J
ID78K0 Integrated Debugger, Windows based	Guide	U11649E	U11649J
SD78K/0 Screen Debugger	Introduction	–	EEU-852
PC-9800 Series (MS-DOS) based	Reference	–	U10952J
SD78K/0 Screen Debugger	Introduction	U10539E	EEU-5024
IBM PC/AT (PC DOS) based	Reference	U11279E	U11279J

Caution   The above related documents are subject to change without notice. Be sure to read the latest documents before designing.

Embedded Software Documents (User's Manual)

Document Name		Document No. (English)	Document No. (Japanese)
78K/0 Series Real-time OS	Fundamental	U11537E	U11537J
	Installation	U11536E	U11536J
78K/0 Series OS MX78K0	Fundamental	U12257E	U12257J
Fuzzy Knowledge Data Creation Tool		EEU-1438	EEU-829
78K/0, 78K/II, 87AD Series Fuzzy Inference Development Support System Translator		EEU-1444	EEU-862
78K/0 Series Fuzzy Inference Development Support System Fuzzy Inference Module		EEU-1441	EEU-858
78K/0 Series Fuzzy Inference Development Support System Fuzzy Inference Debugger		EEU-1458	EEU-921

Other Documents

Document Name	Document No. (English)	Document No. (Japanese)
IC Package Manual	C10943X	
Semiconductor Device Mounting Technology Manual	C10535E	C10535J
Quality Grades on NEC Semiconductor Devices	C11531E	C11531J
NEC Semiconductor Device Reliability/Quality Control System	C10983E	C10983J
Electrostatic Discharge (ESD) Test	–	MEM-539
Guide to Quality Assurance for Semiconductor Devices	MEI-1202	C11893J
Microcomputer Product Series Guide	–	U11416J

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[MEMO]

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┌─────────── NOTES FOR CMOS DEVICES ───────────┐
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① PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note: Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

② HANDLING OF UNUSED INPUT PINS FOR CMOS

Note: No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to V_{DD} or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

③ STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note: Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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Regional Information

Some information contained in this document may vary from country to country. Before using any NEC product in your application, please contact the NEC office in your country to obtain a list of authorized representatives and distributors. They will verify:

• Device availability

• Ordering information

• Product release schedule

• Availability of related technical literature

• Development environment specifications (for example, specifications for third-party tools and components, host computers, power plugs, AC supply voltages, and so forth)

• Network requirements

In addition, trademarks, registered trademarks, export restrictions, and other legal issues may also vary from country to country.

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Santa Clara, California
Tel: 800-366-9782
Fax: 800-729-9288

NEC Electronics (Germany) GmbH
Duesseldorf, Germany
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Fax: 0211-65 03 490

NEC Electronics (UK) Ltd.
Milton Keynes, UK
Tel: 01908-691-133
Fax: 01908-670-290

NEC Electronics Italiana s.r.1.
Milano, Italy
Tel: 02-66 75 41
Fax: 02-66 75 42 99

NEC Electronics (Germany) GmbH
Benelux Office
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NEC Electronics (France) S.A.
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NEC Electronics Hong Kong Ltd.
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NEC Electronics Singapore Pte. Ltd.
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Fax: 250-3583

NEC Electronics Taiwan Ltd.
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μPD78056FY, 78058FY
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   Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

   Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

   Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.

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